

1/37

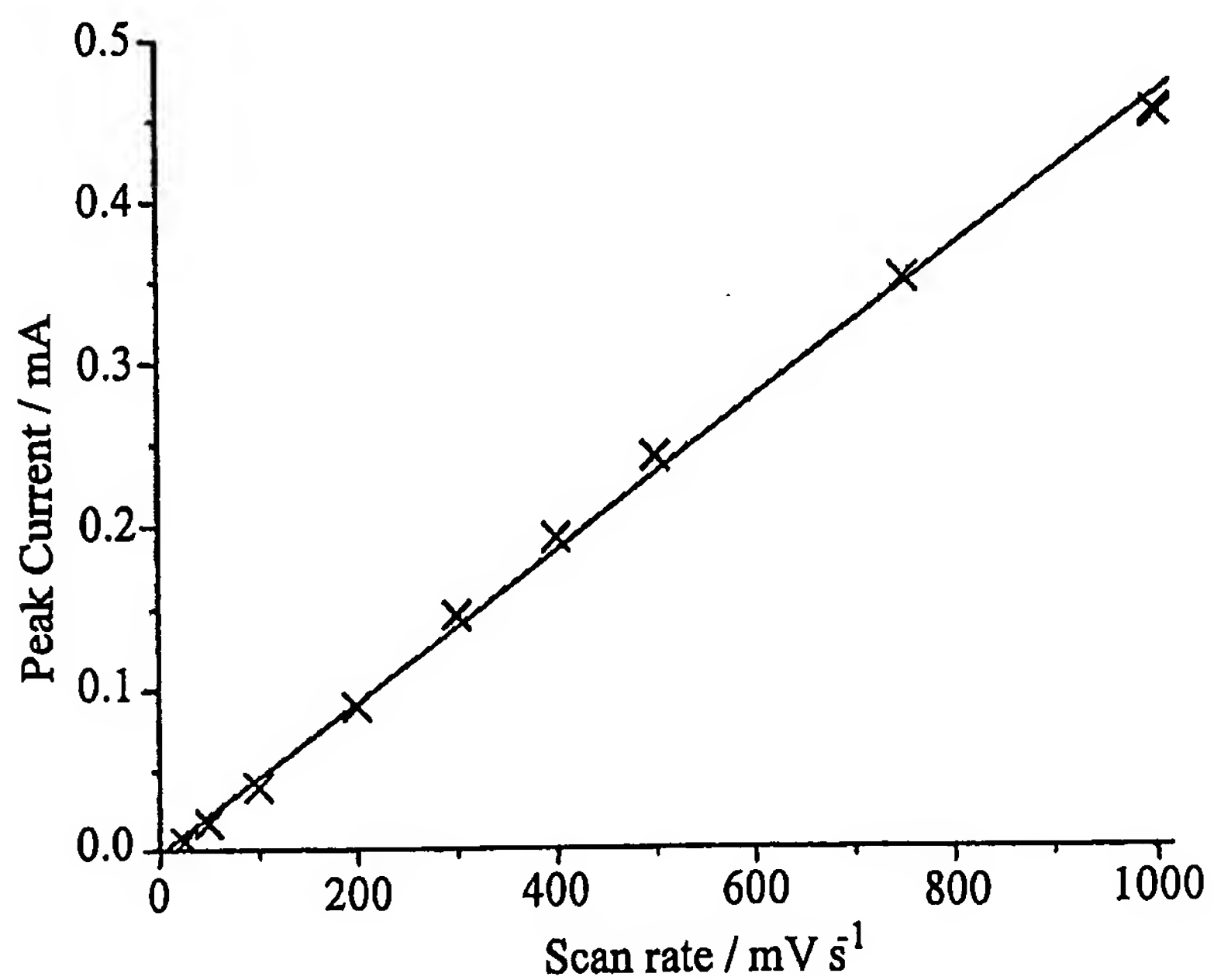
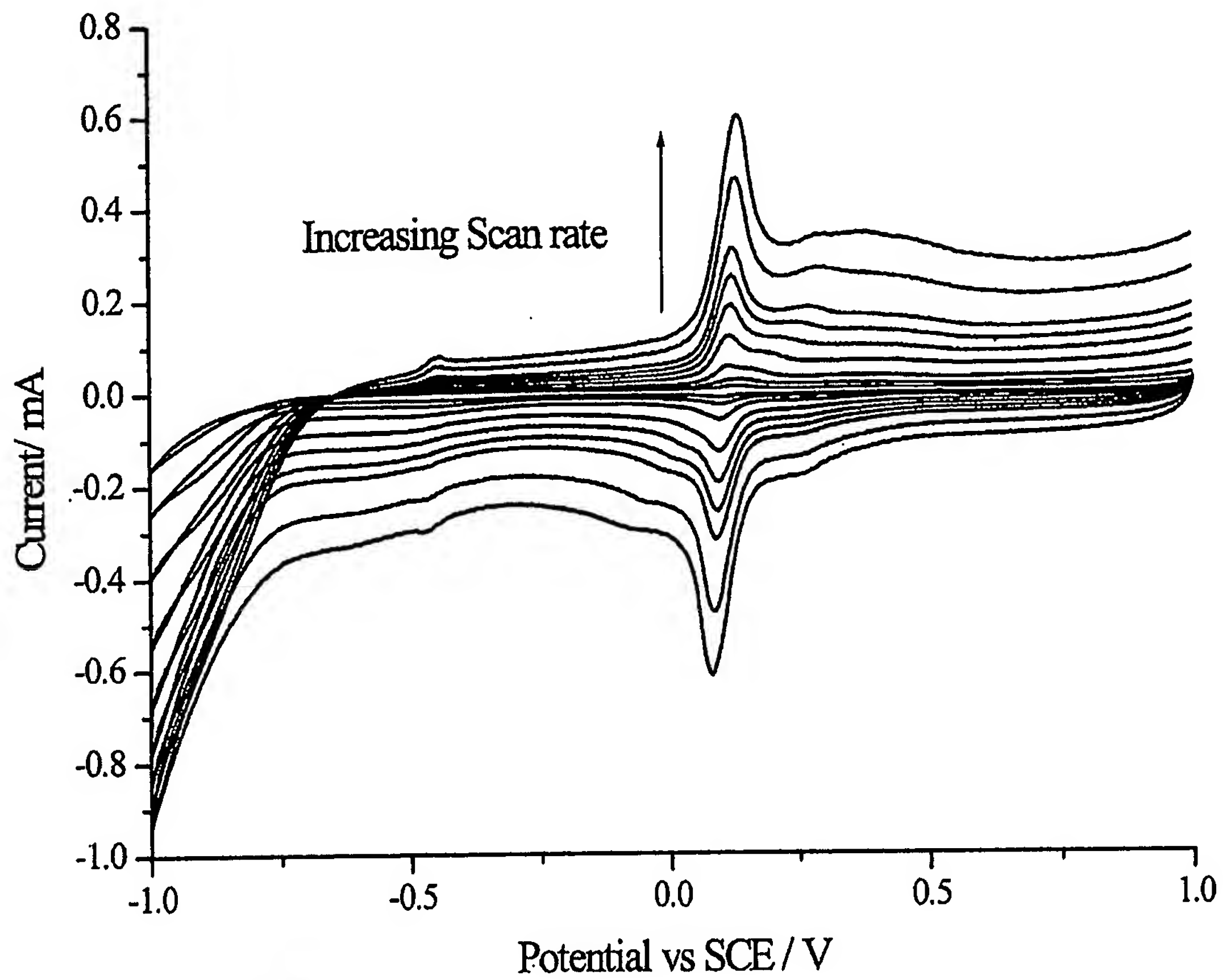


Fig 1

BEST AVAILABLE COPY

2/37

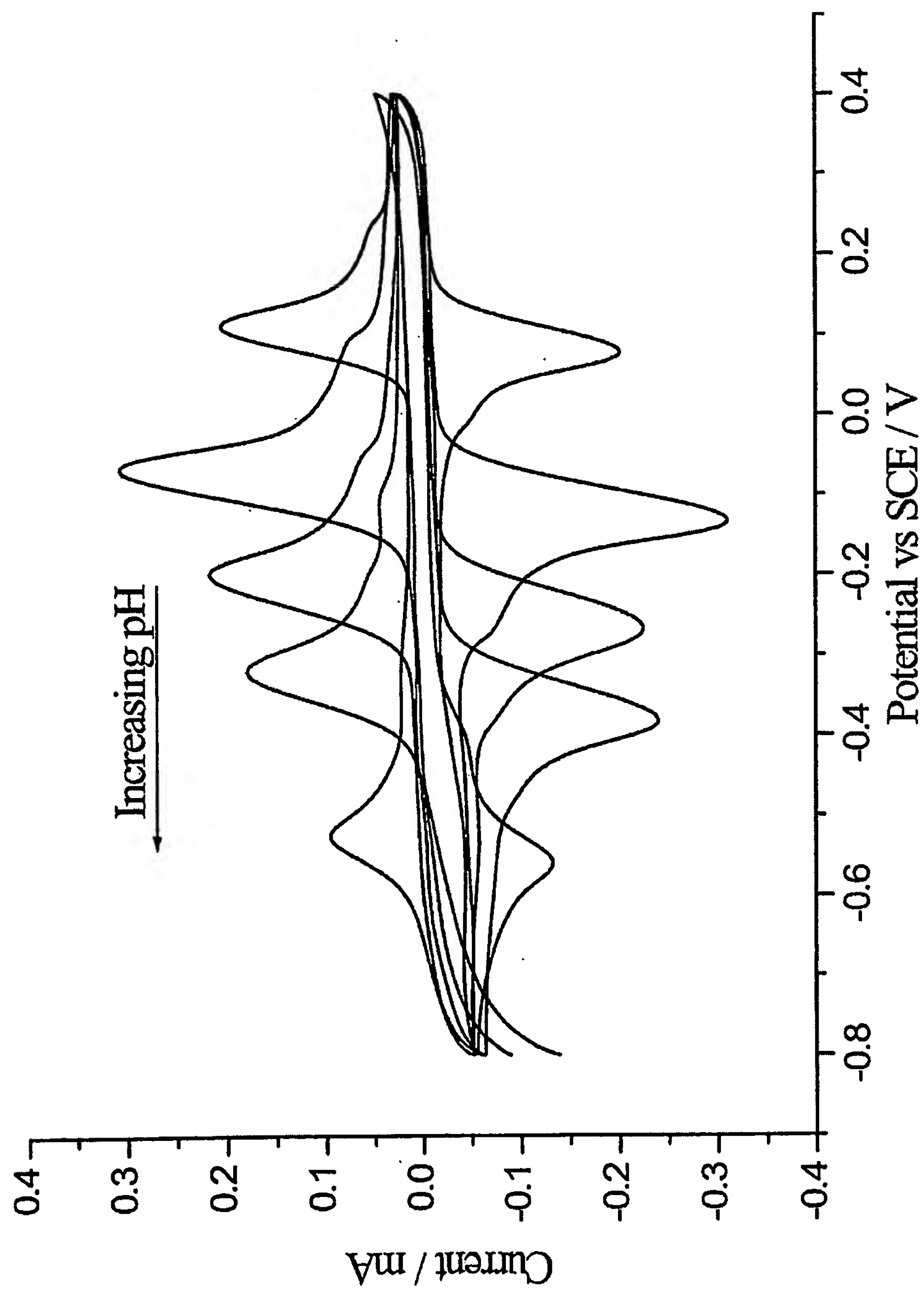


Fig. 2

3/37

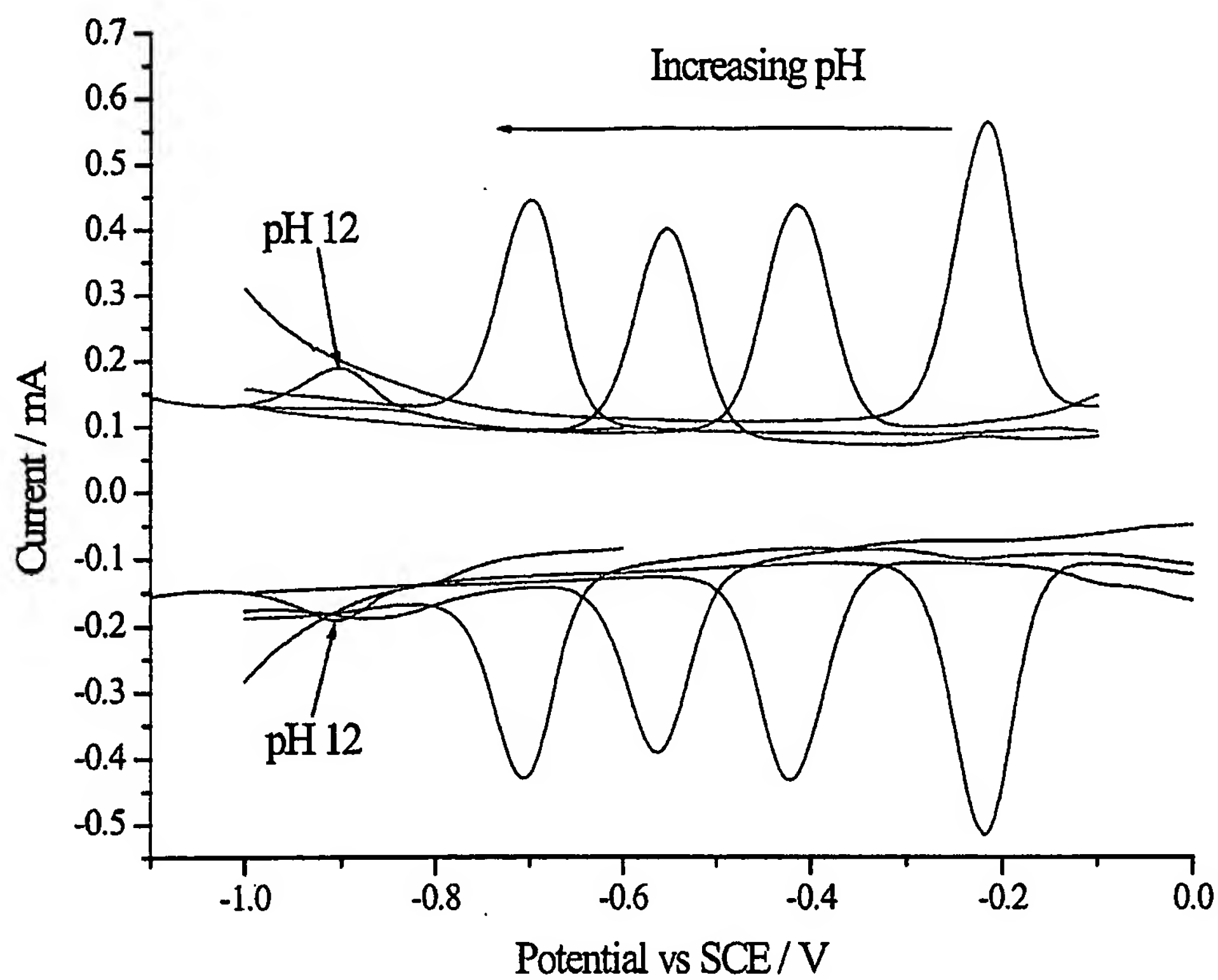


Fig. 3a

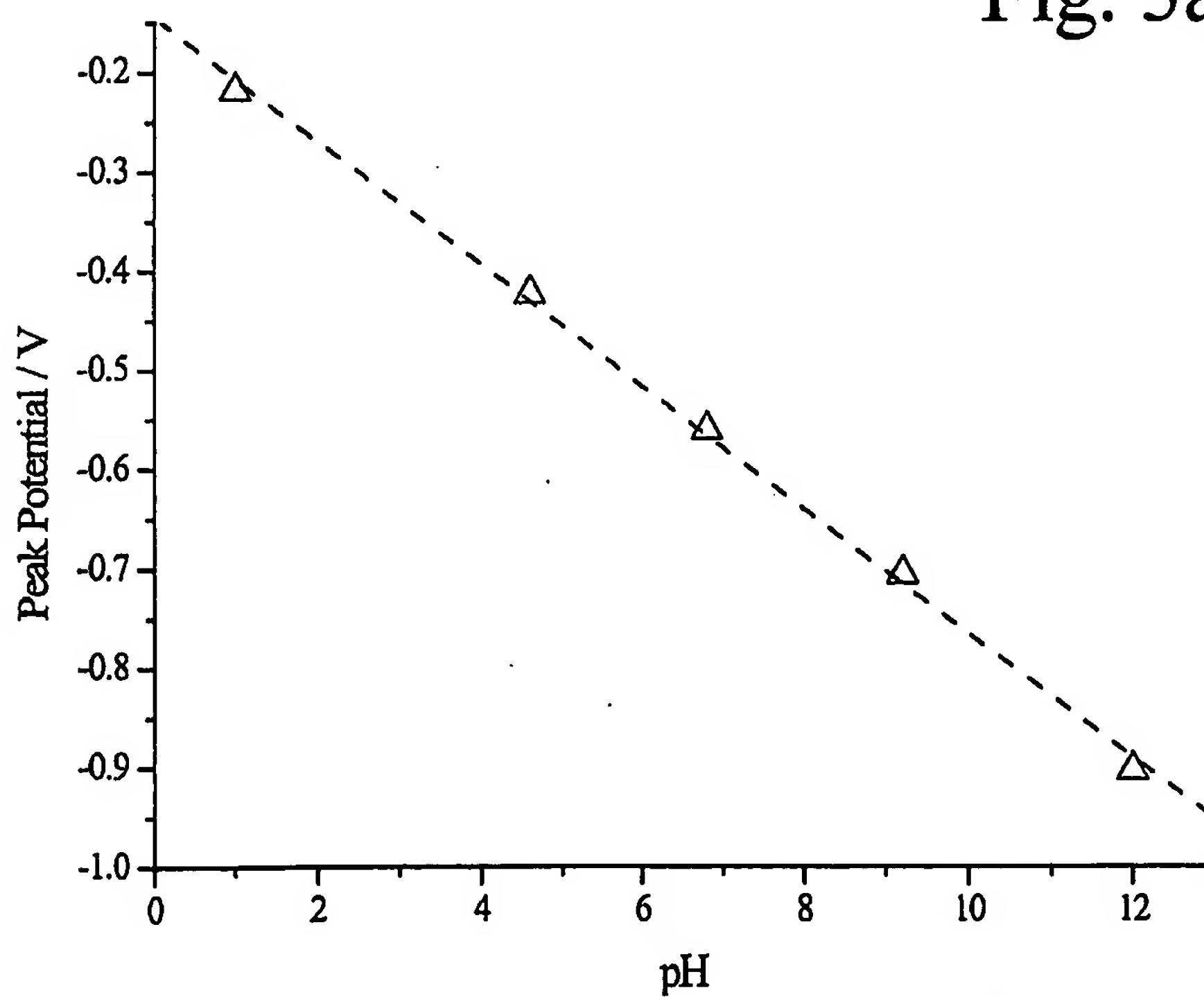


Fig. 3b

4/37

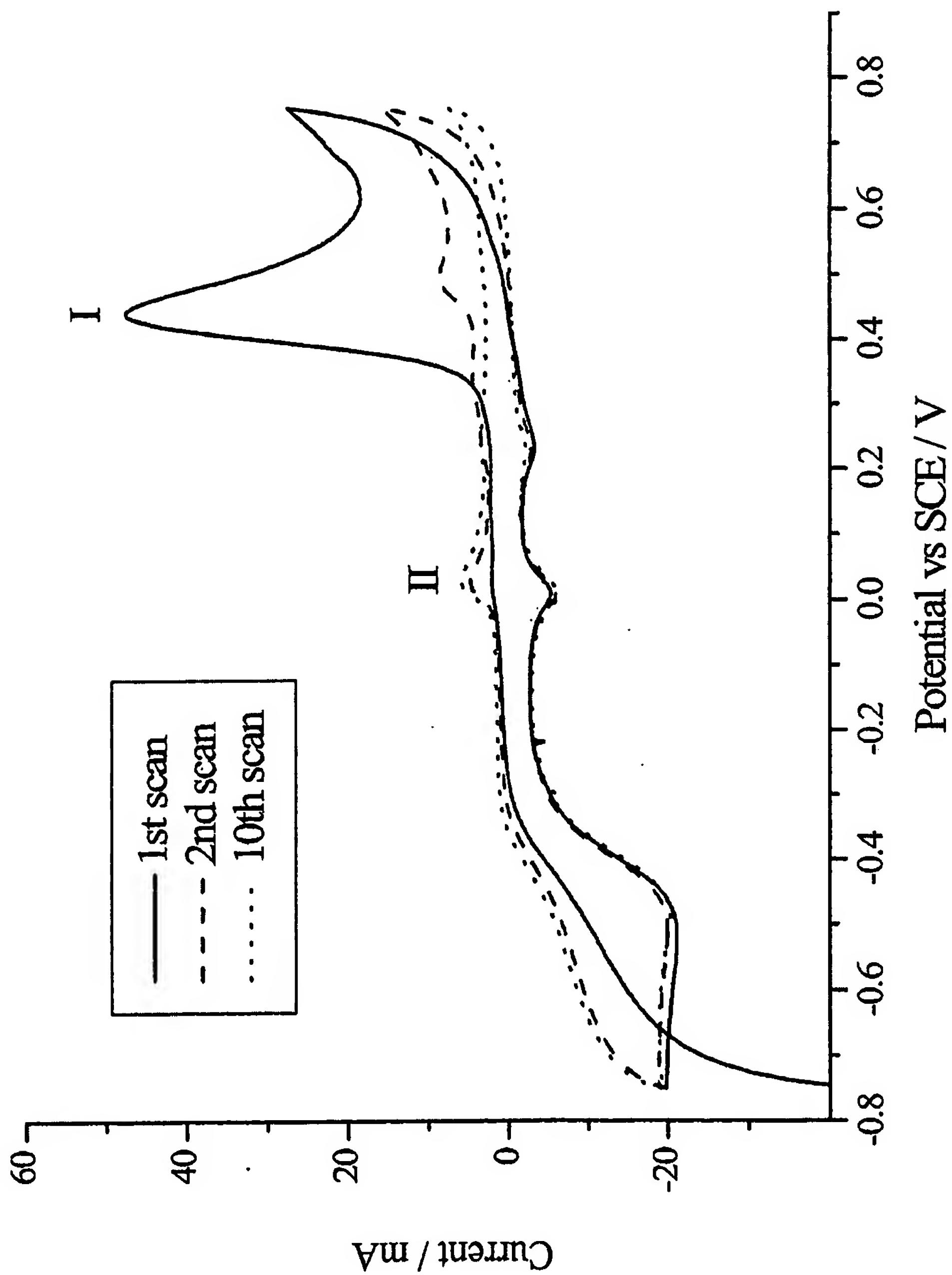


Fig. 4

5/37

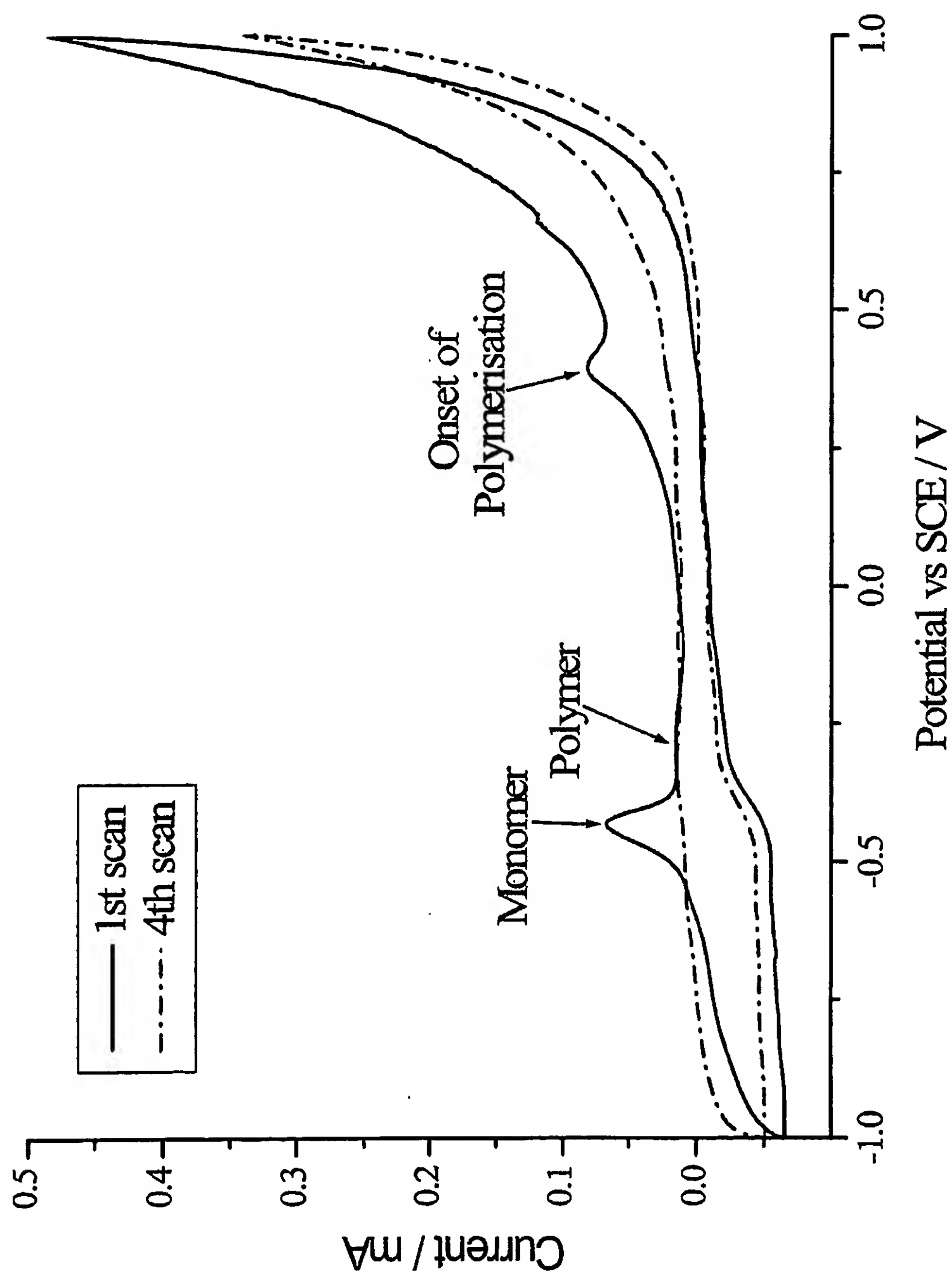


Fig. 5

6/37

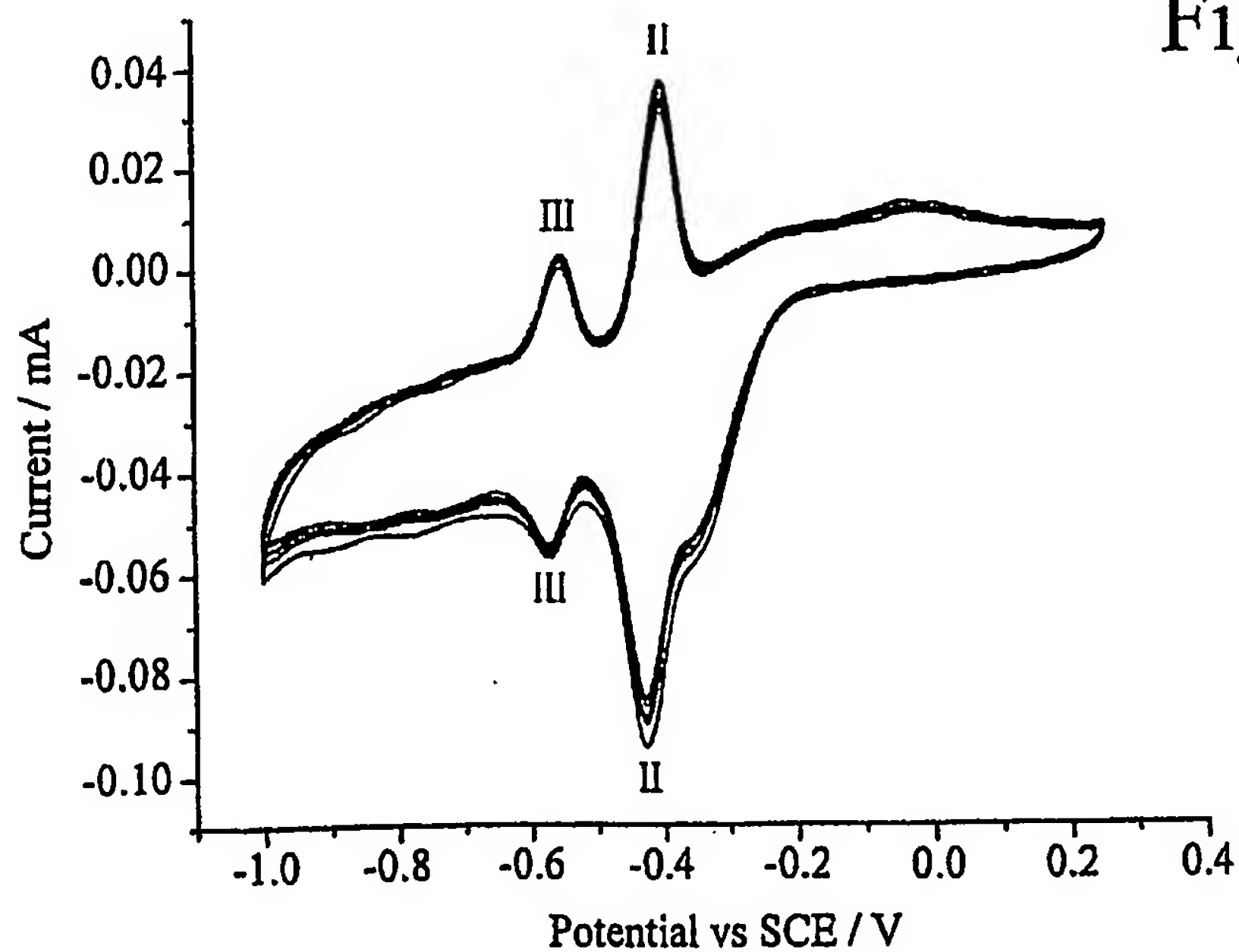
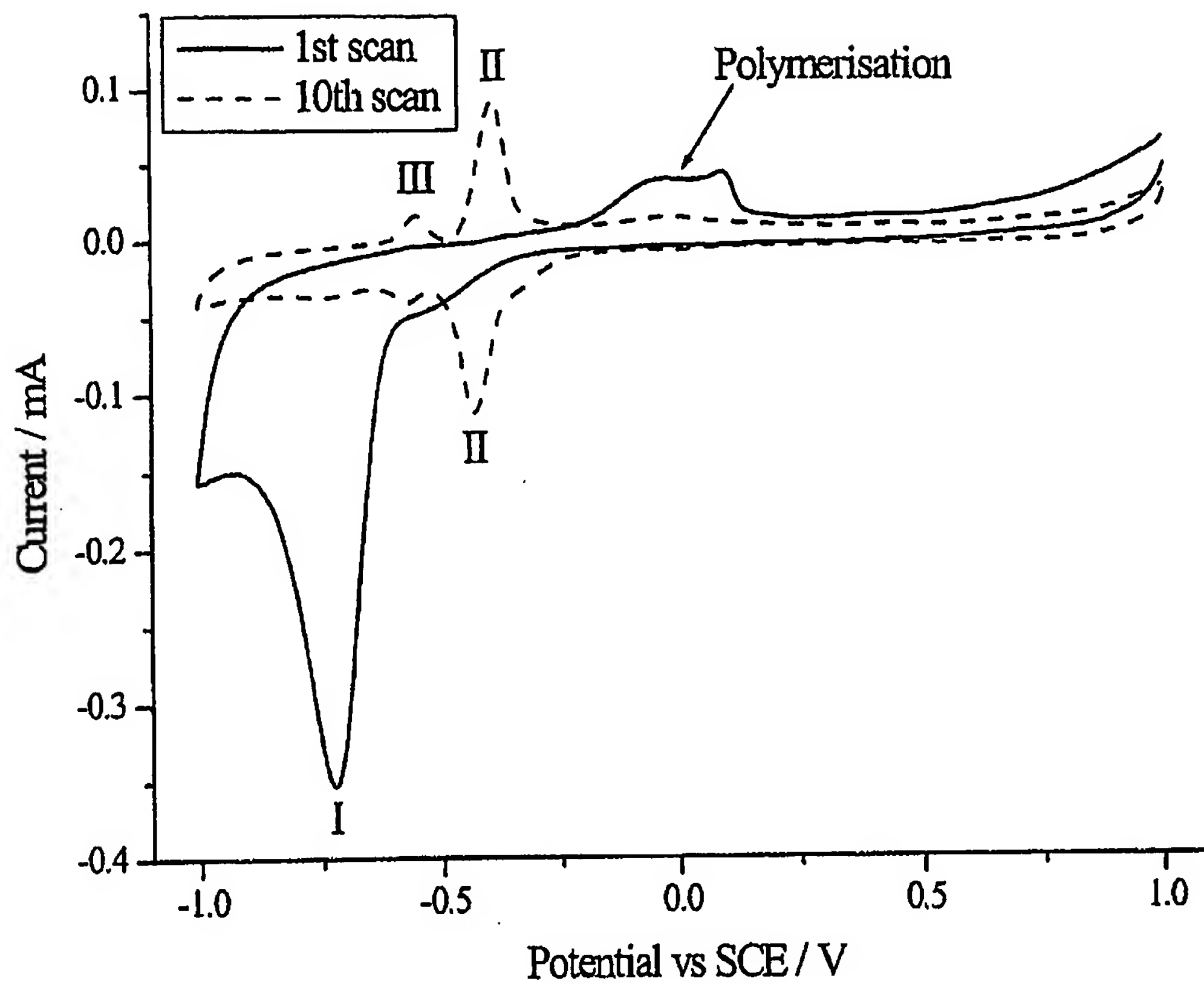


Fig. 6

7/37

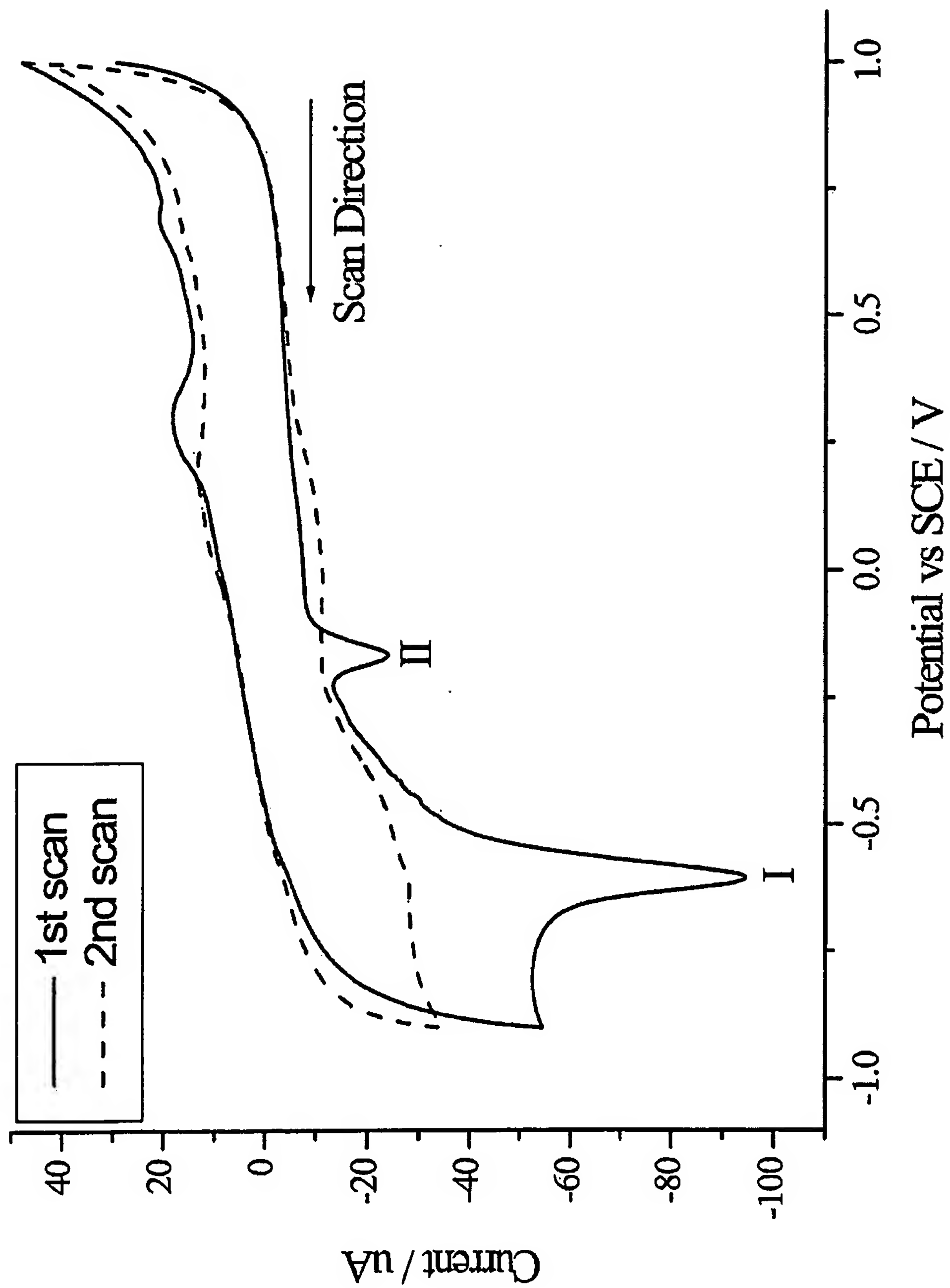


Fig. 7

8/37

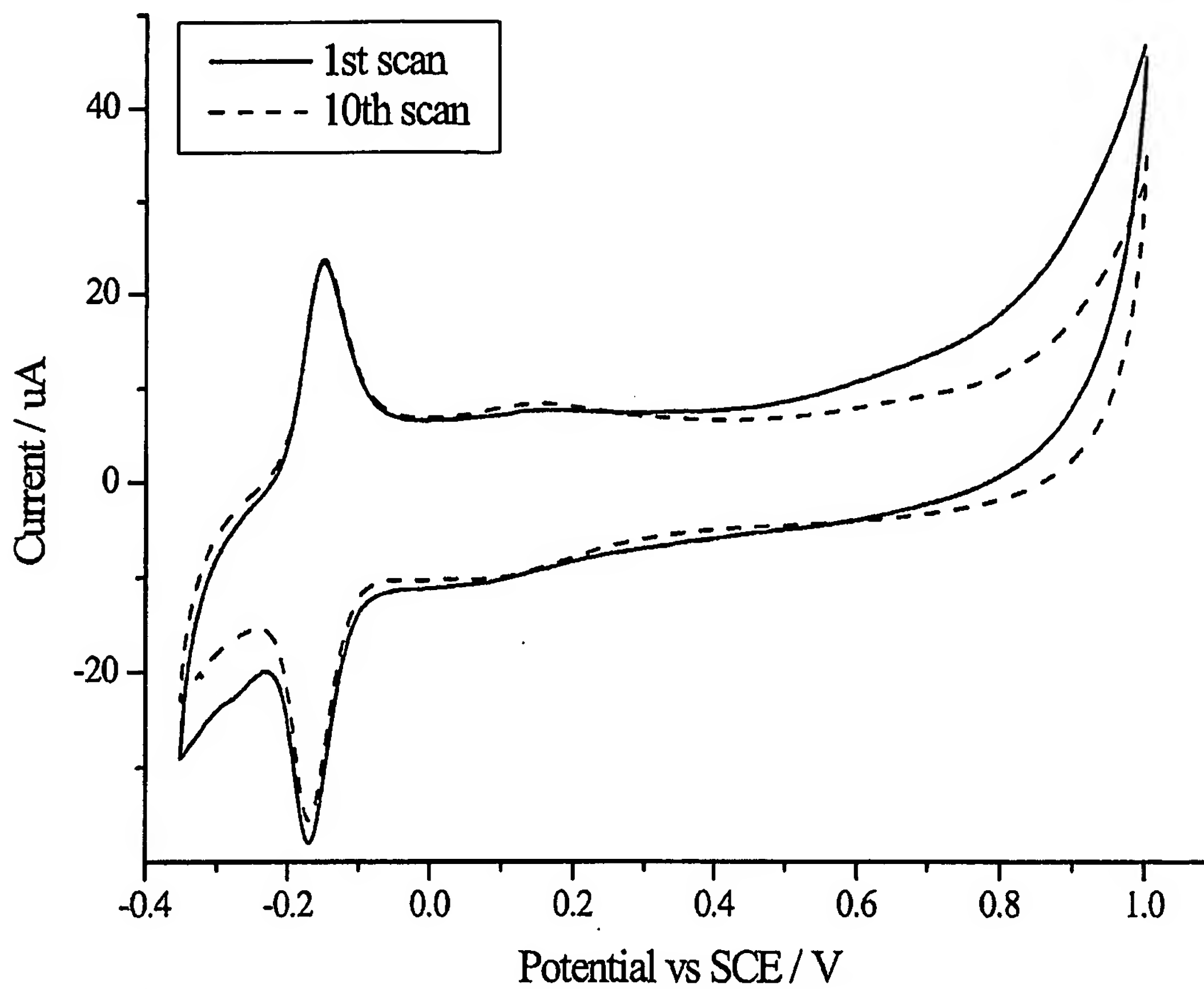
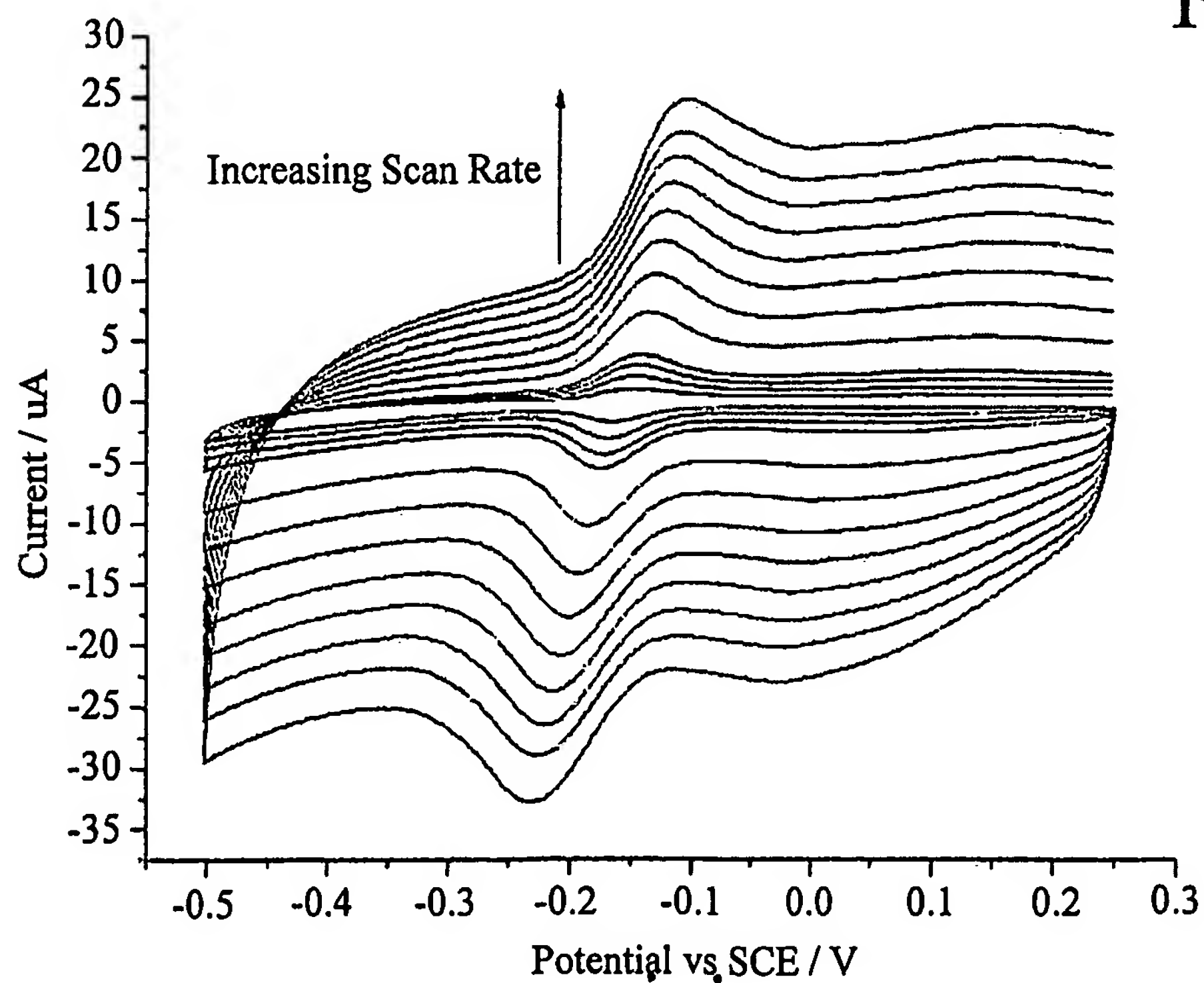


Fig. 8



9/37

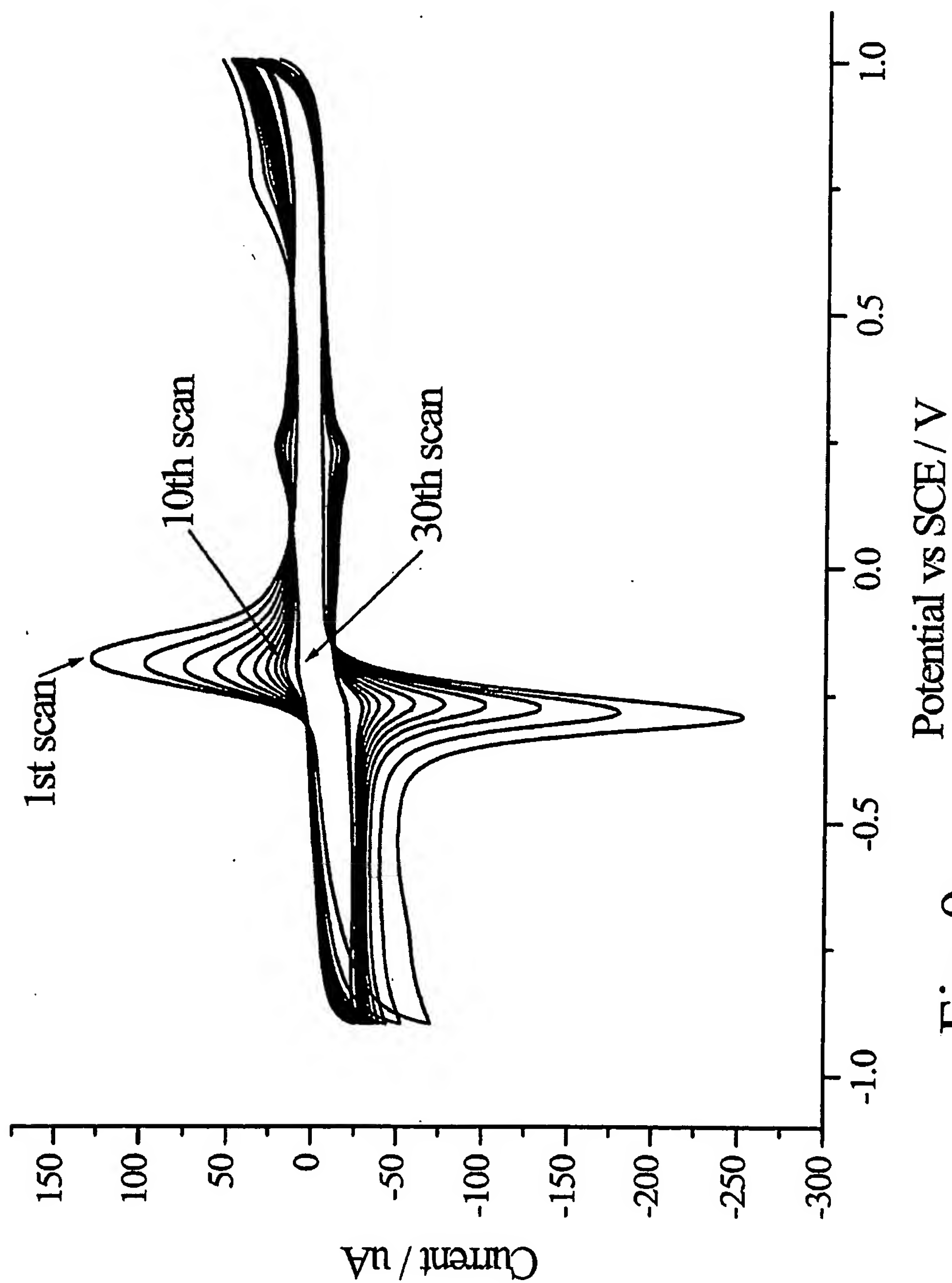


Fig. 9

10/37

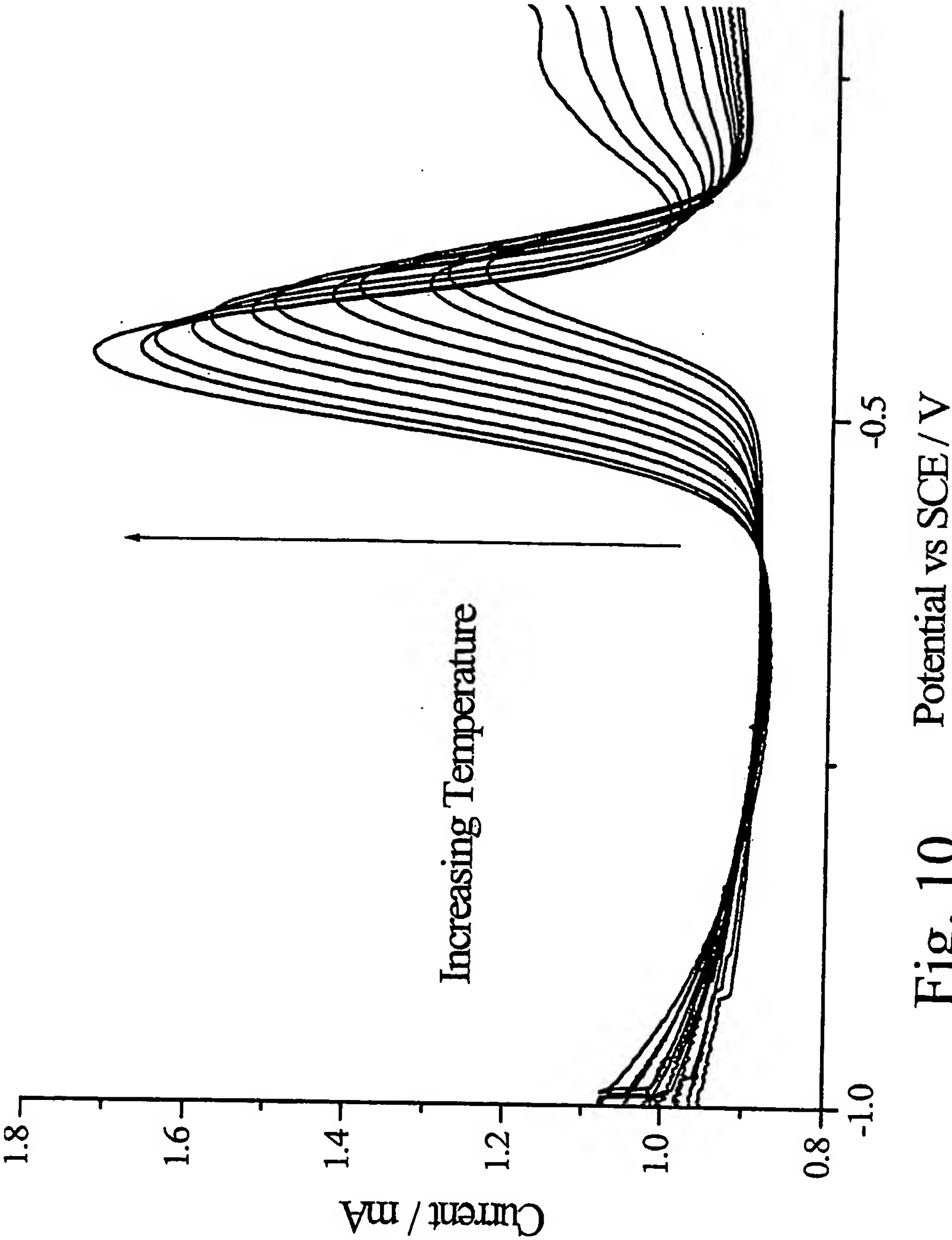


Fig. 10 Potential vs SCE / V

11/37

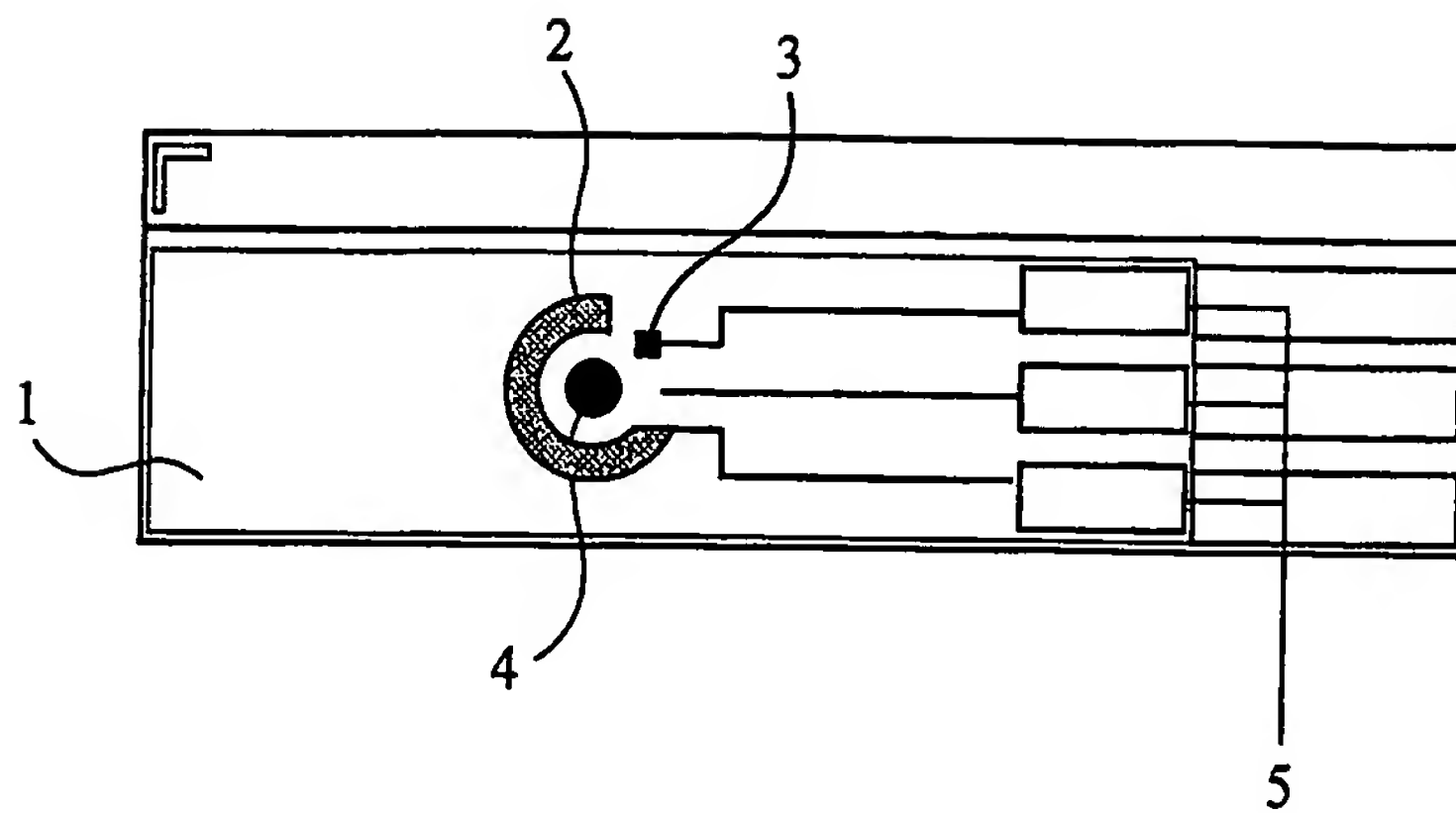


Fig. 11

12/37

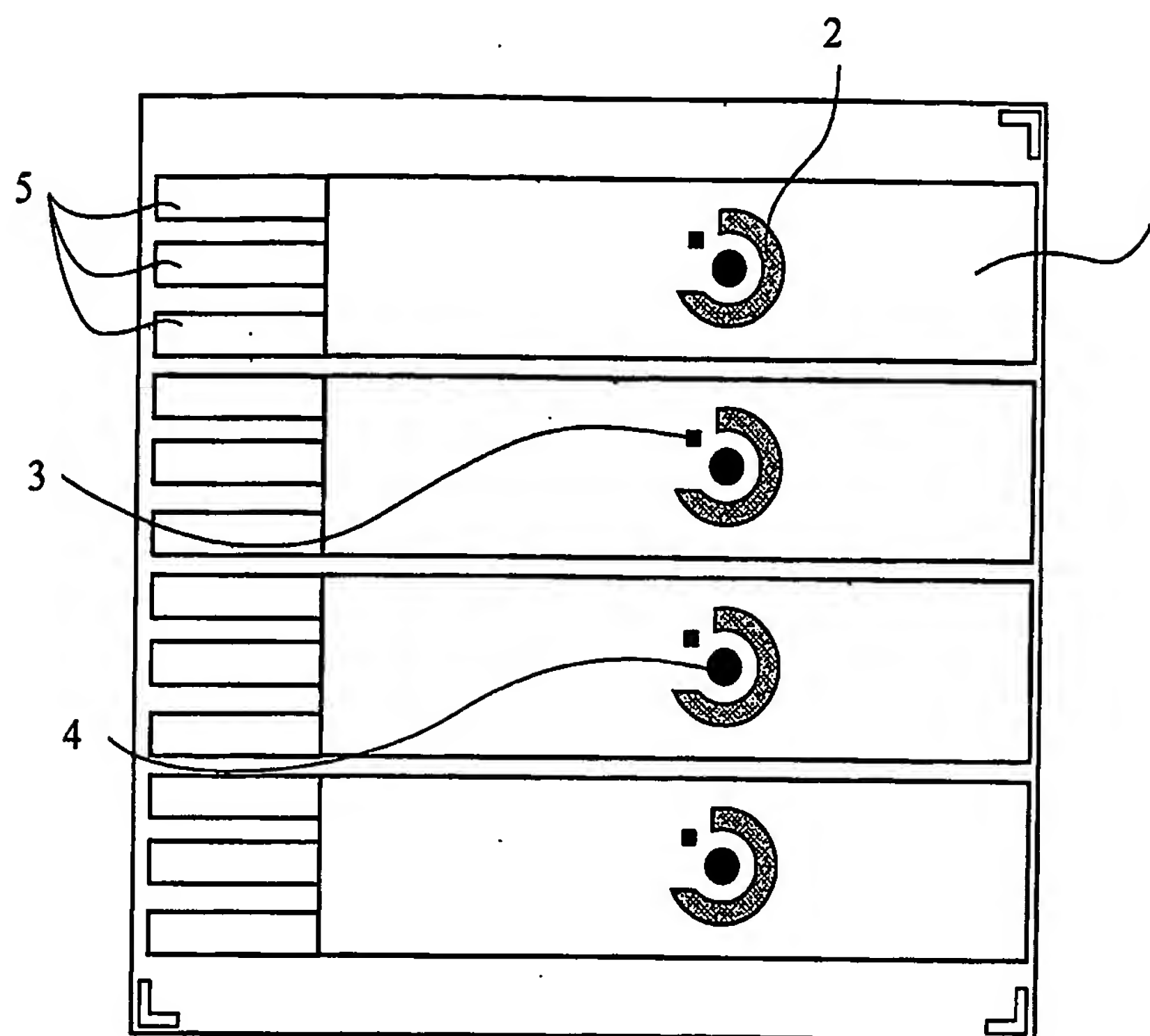


Fig. 12

13/37

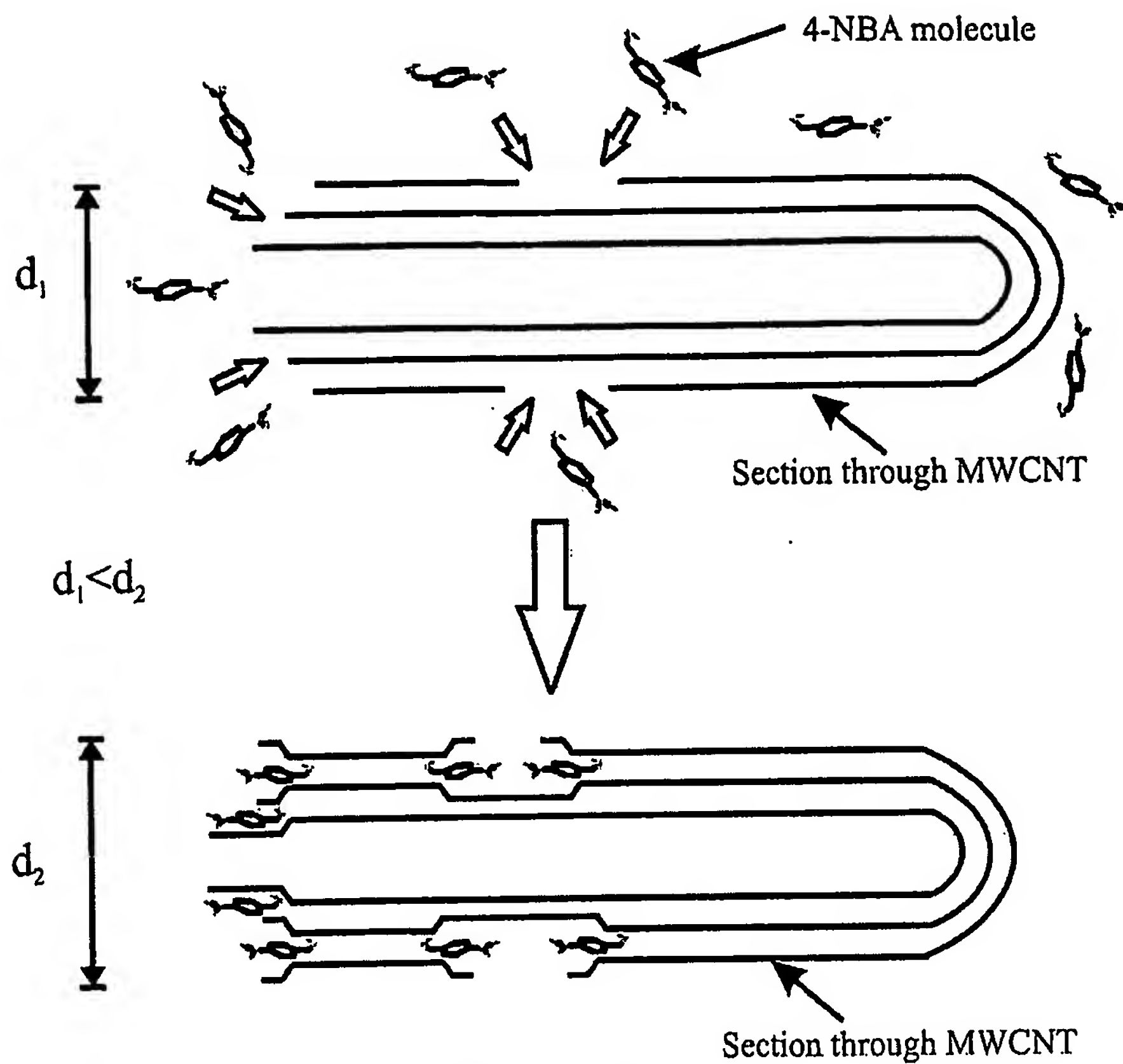


Fig. 13

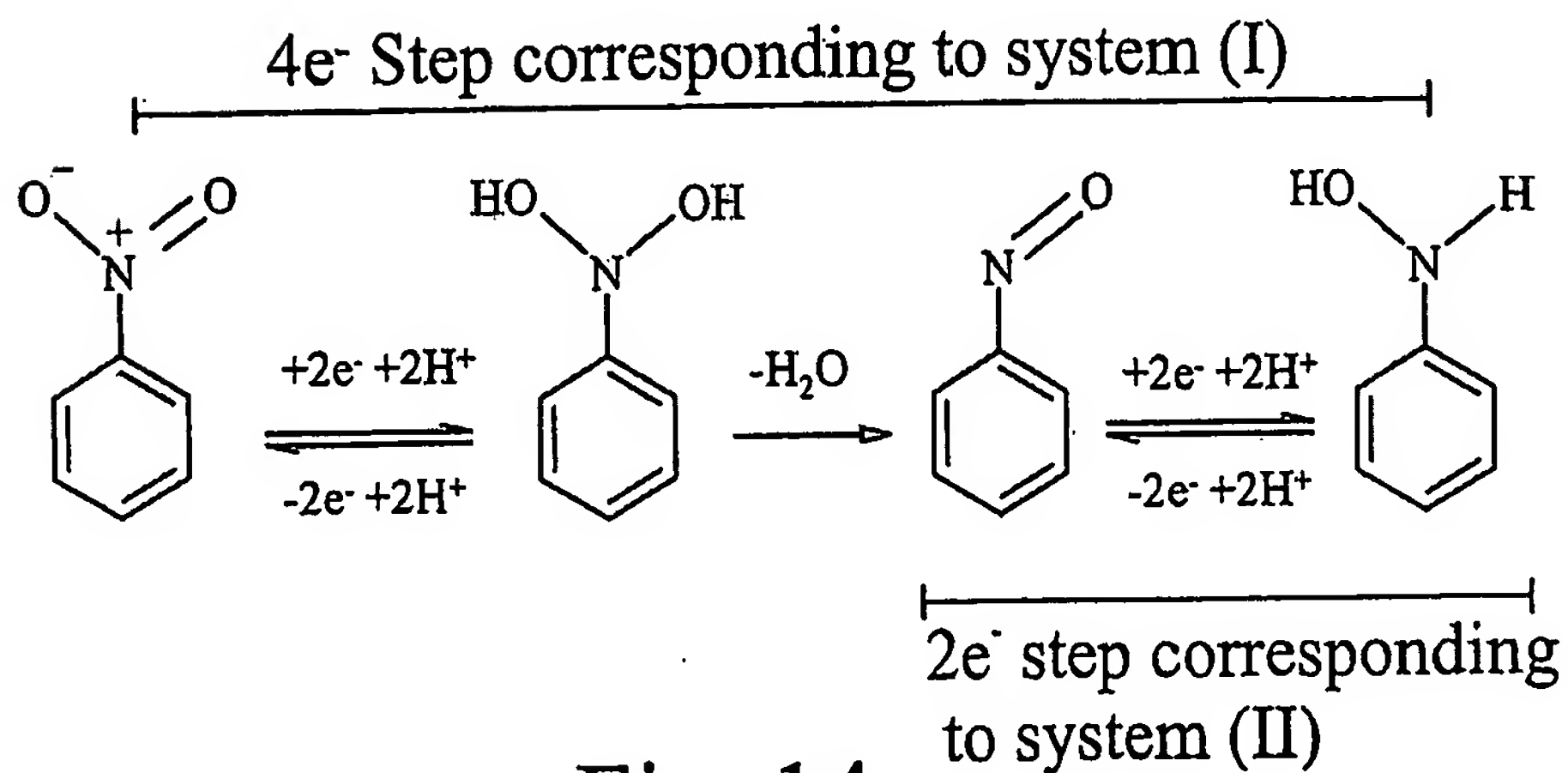


Fig. 14

14/37

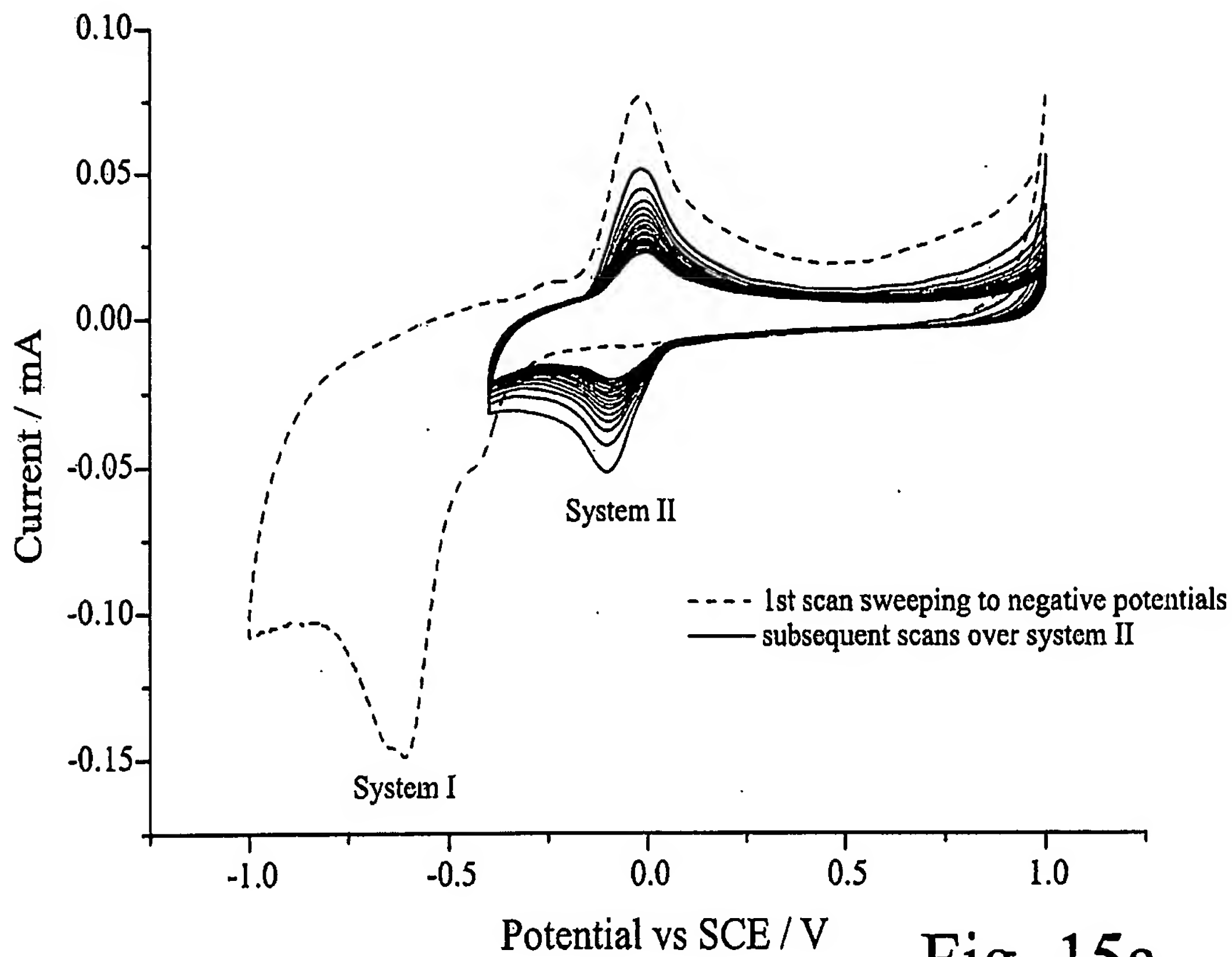


Fig. 15a

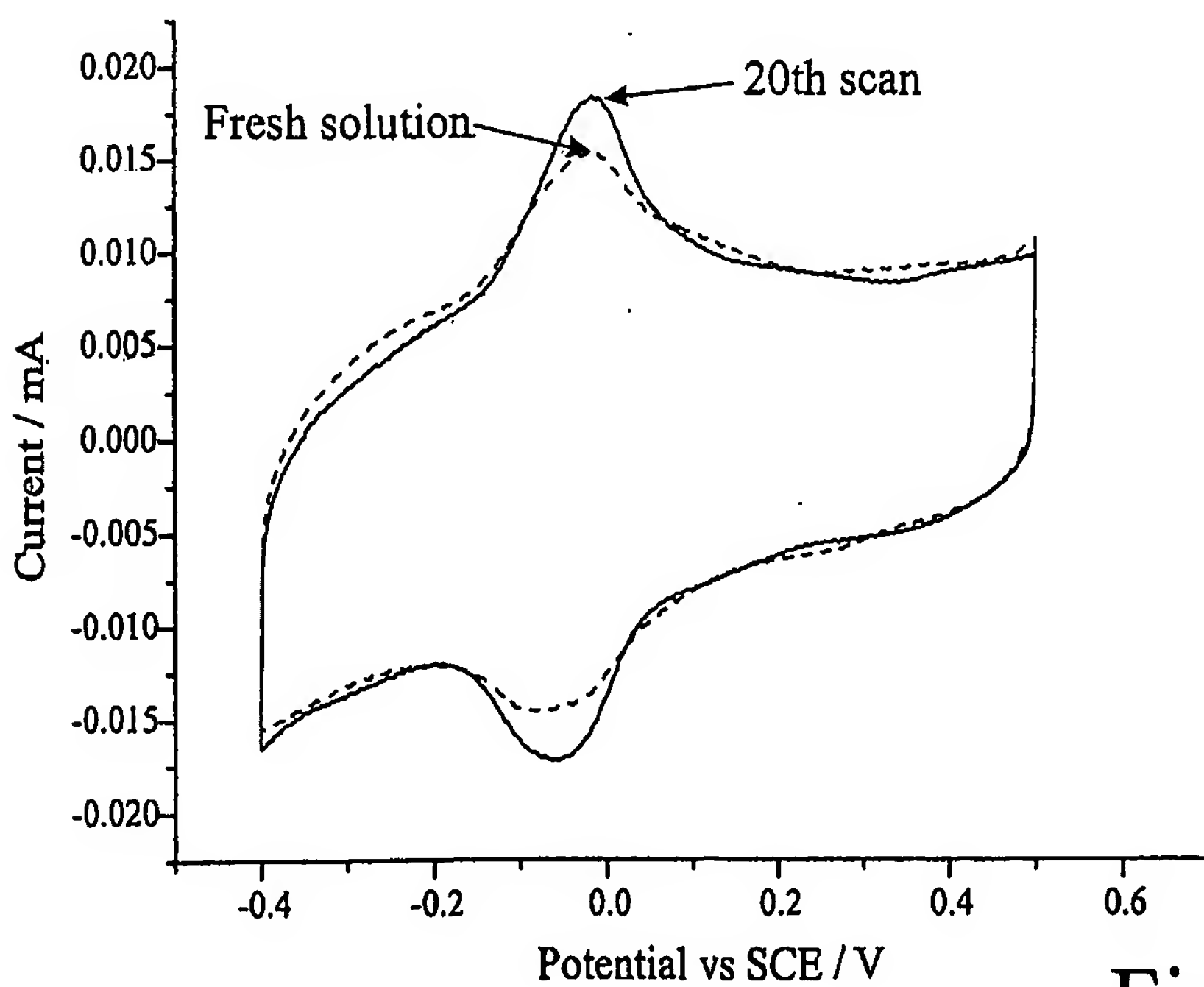


Fig. 15b

WO 2005/085825

PCT/GB2005/000802

15/37

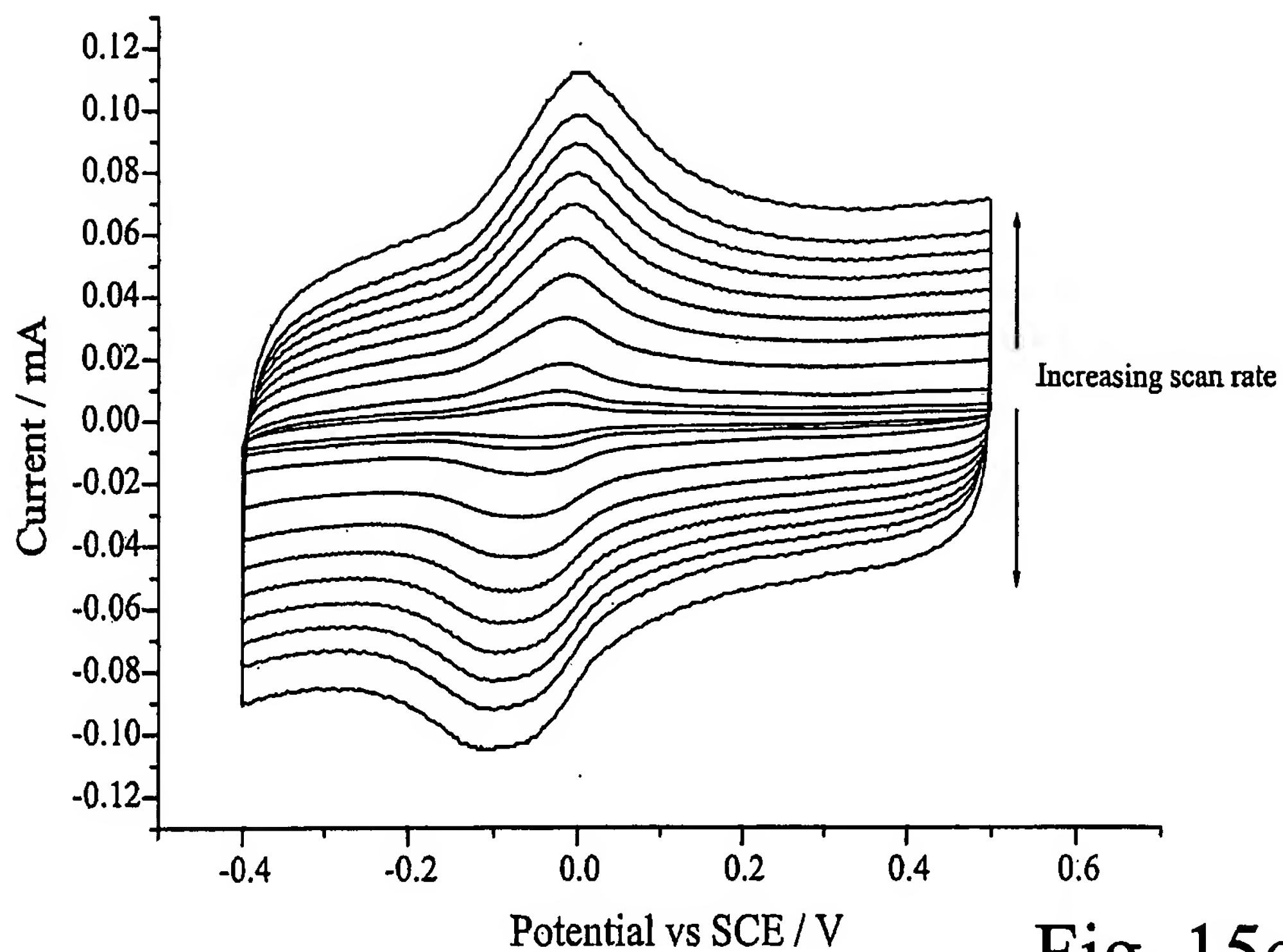


Fig. 15c

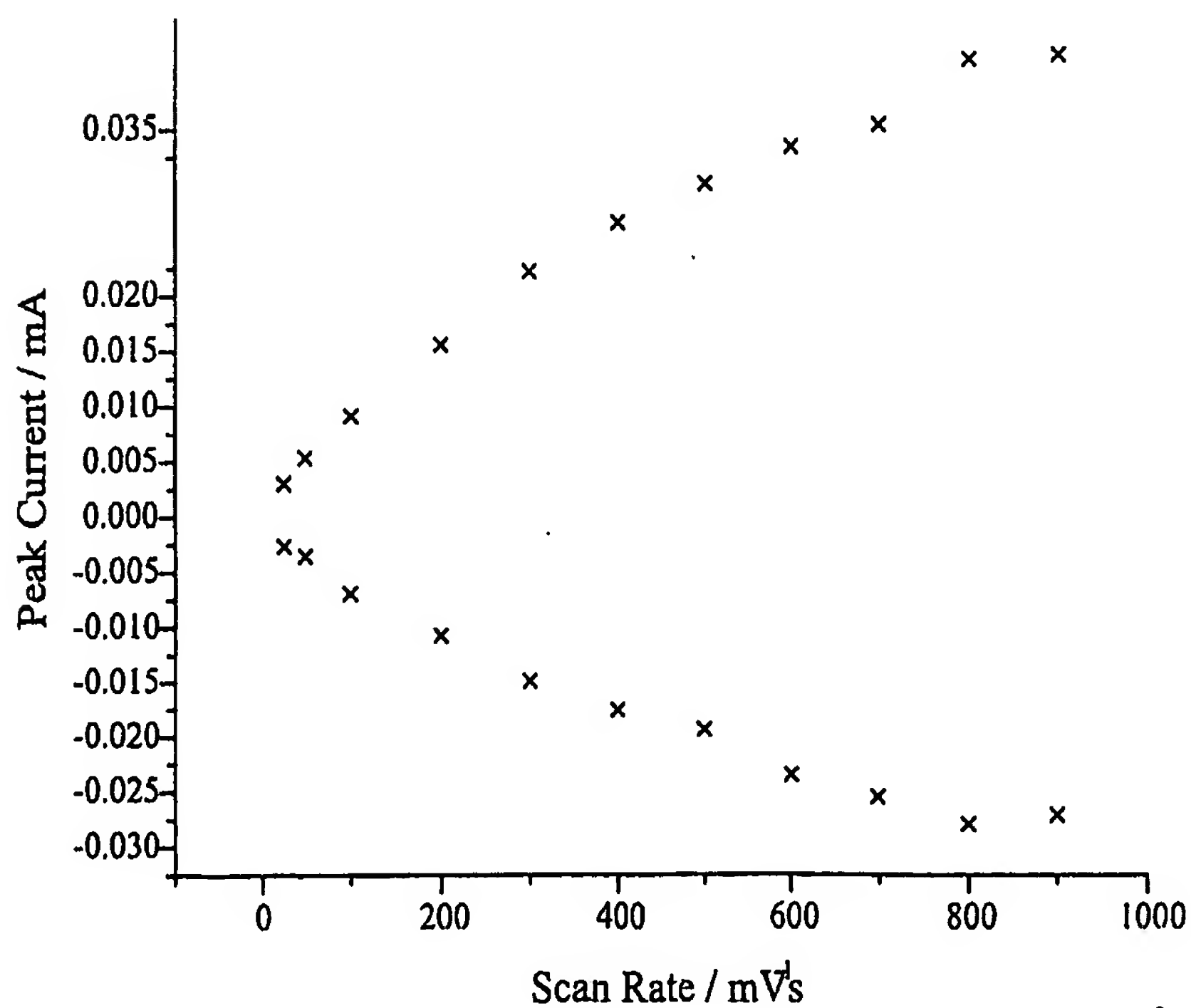


Fig. 15d

WO 2005/085825

PCT/GB2005/000802

16/37

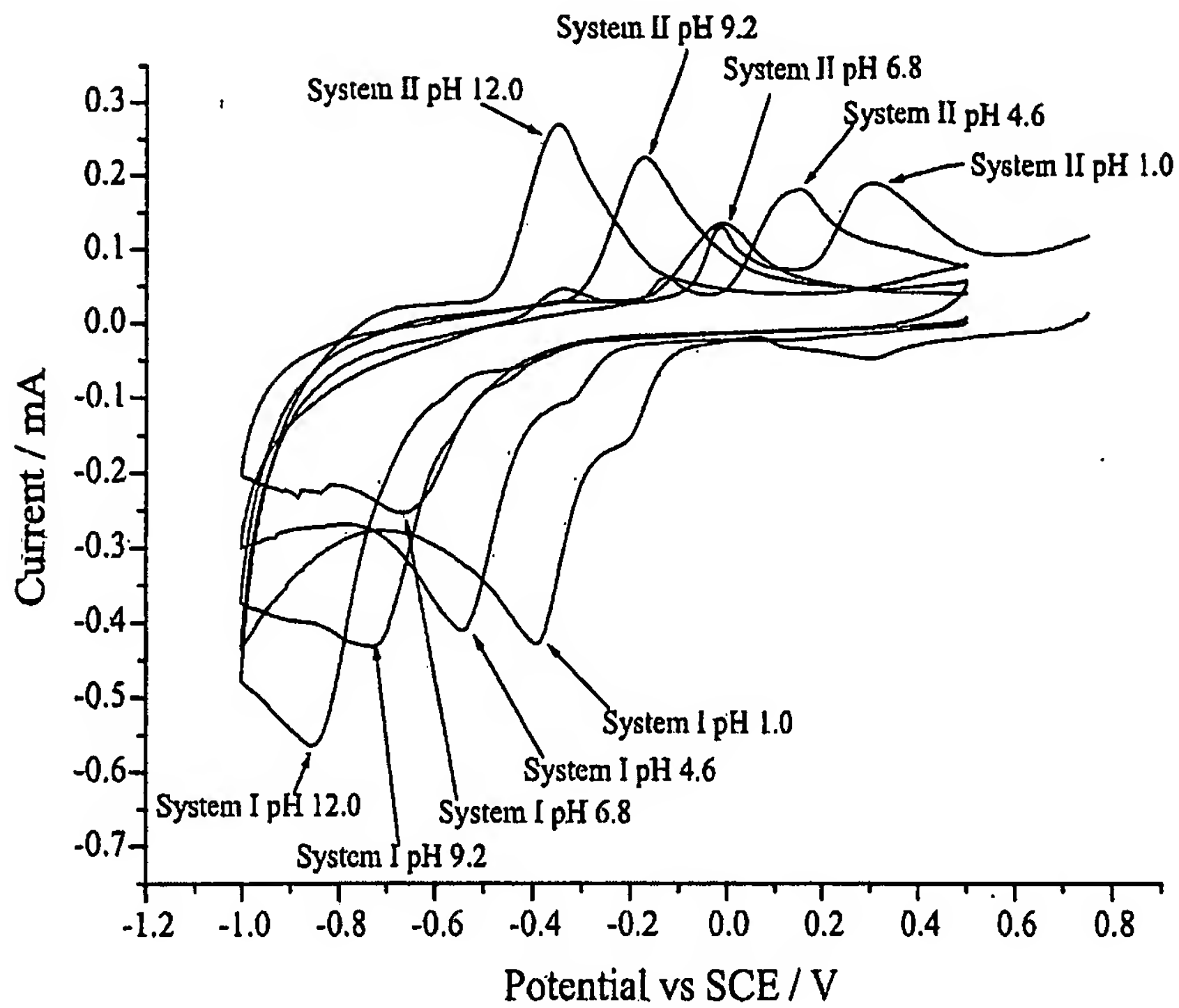


Fig. 16a

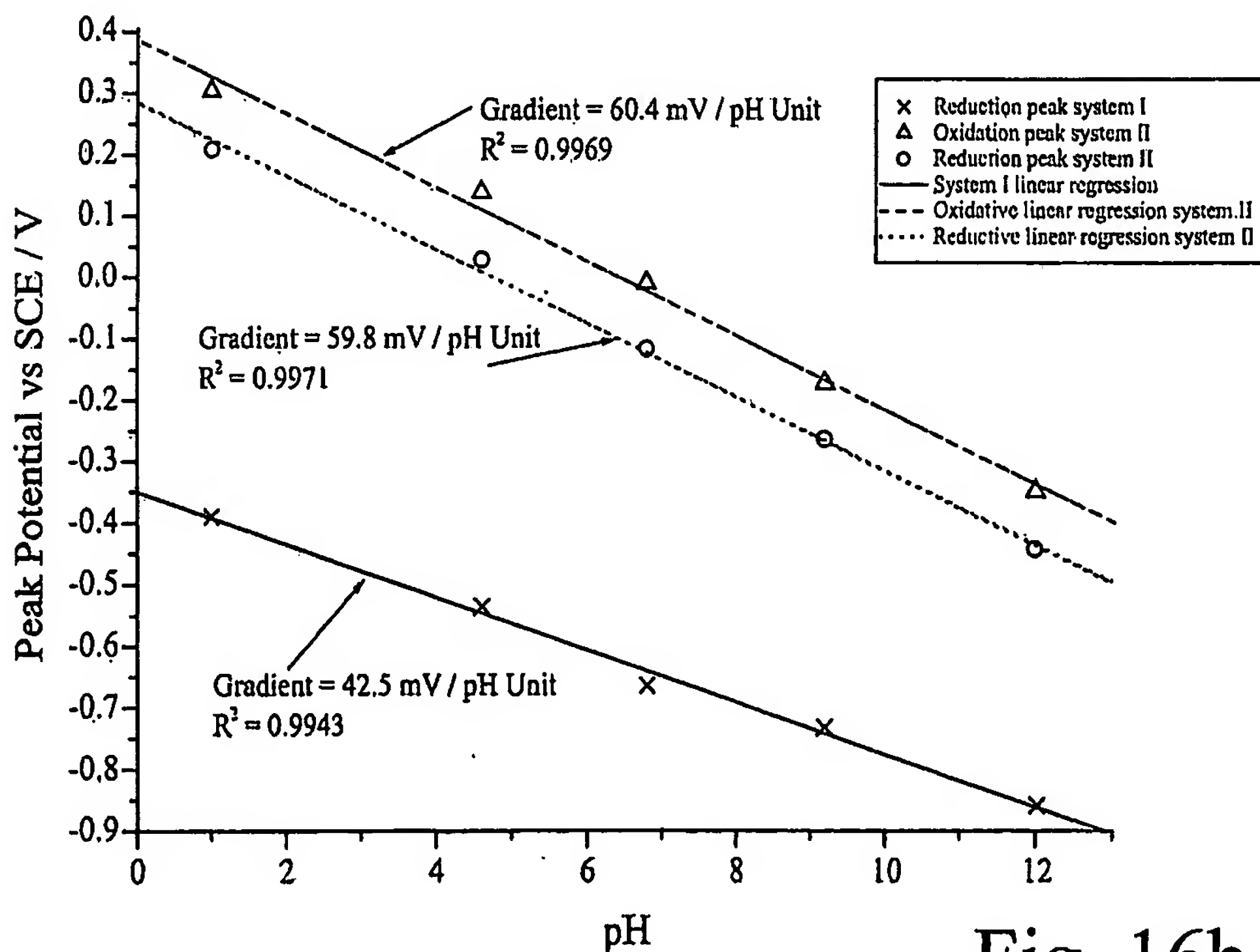


Fig. 16b

17/37

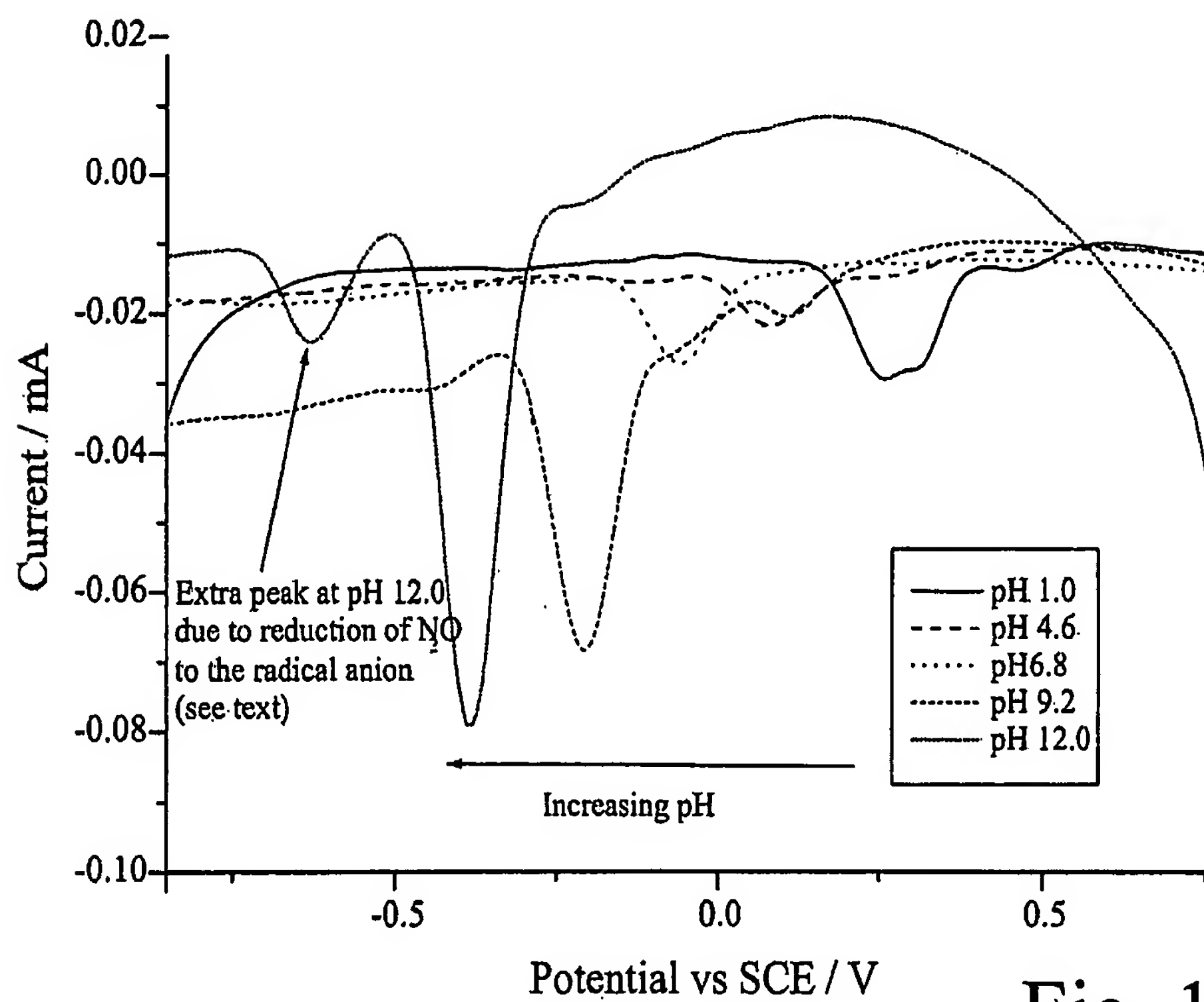


Fig. 17a

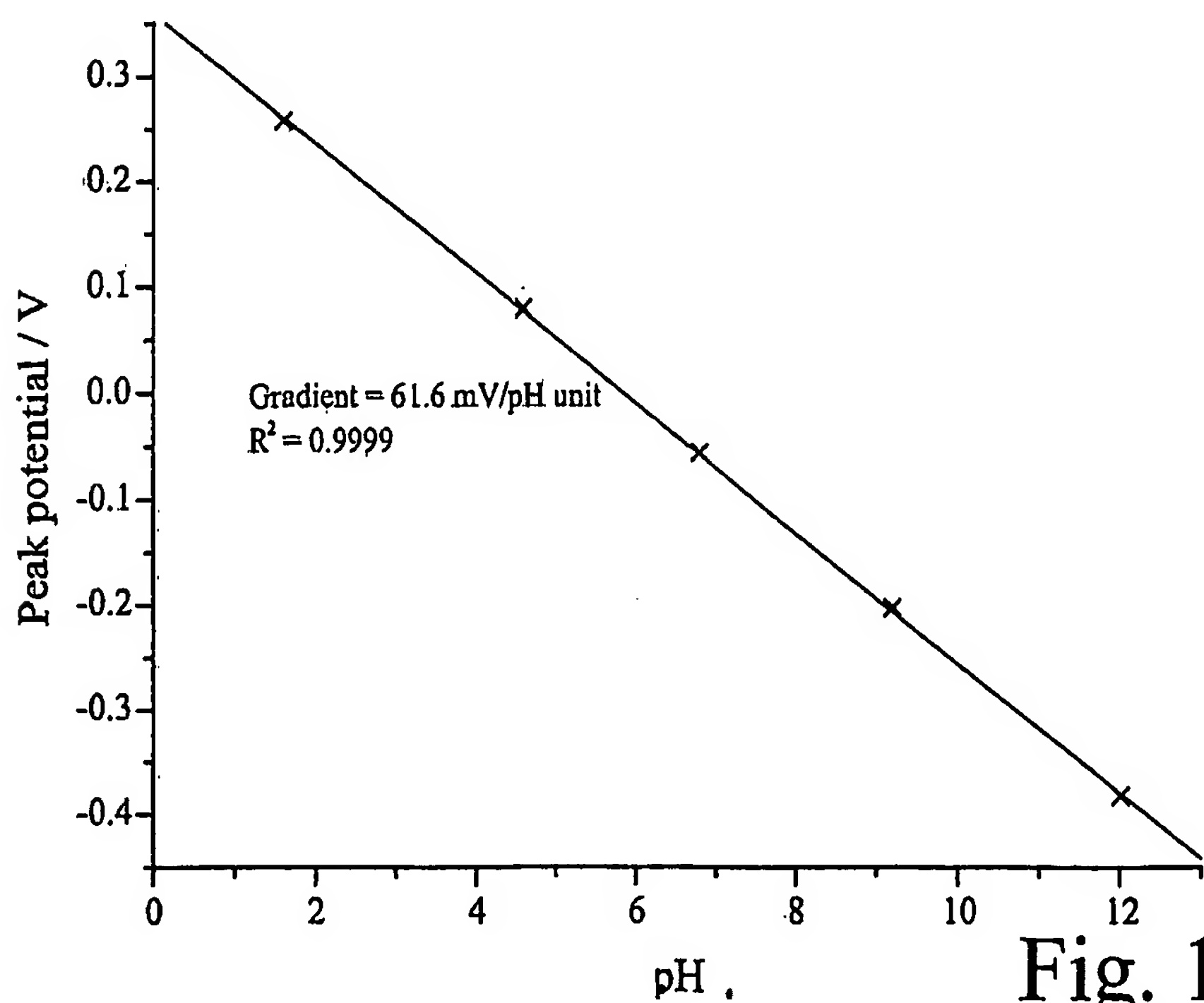


Fig. 17b

18/37

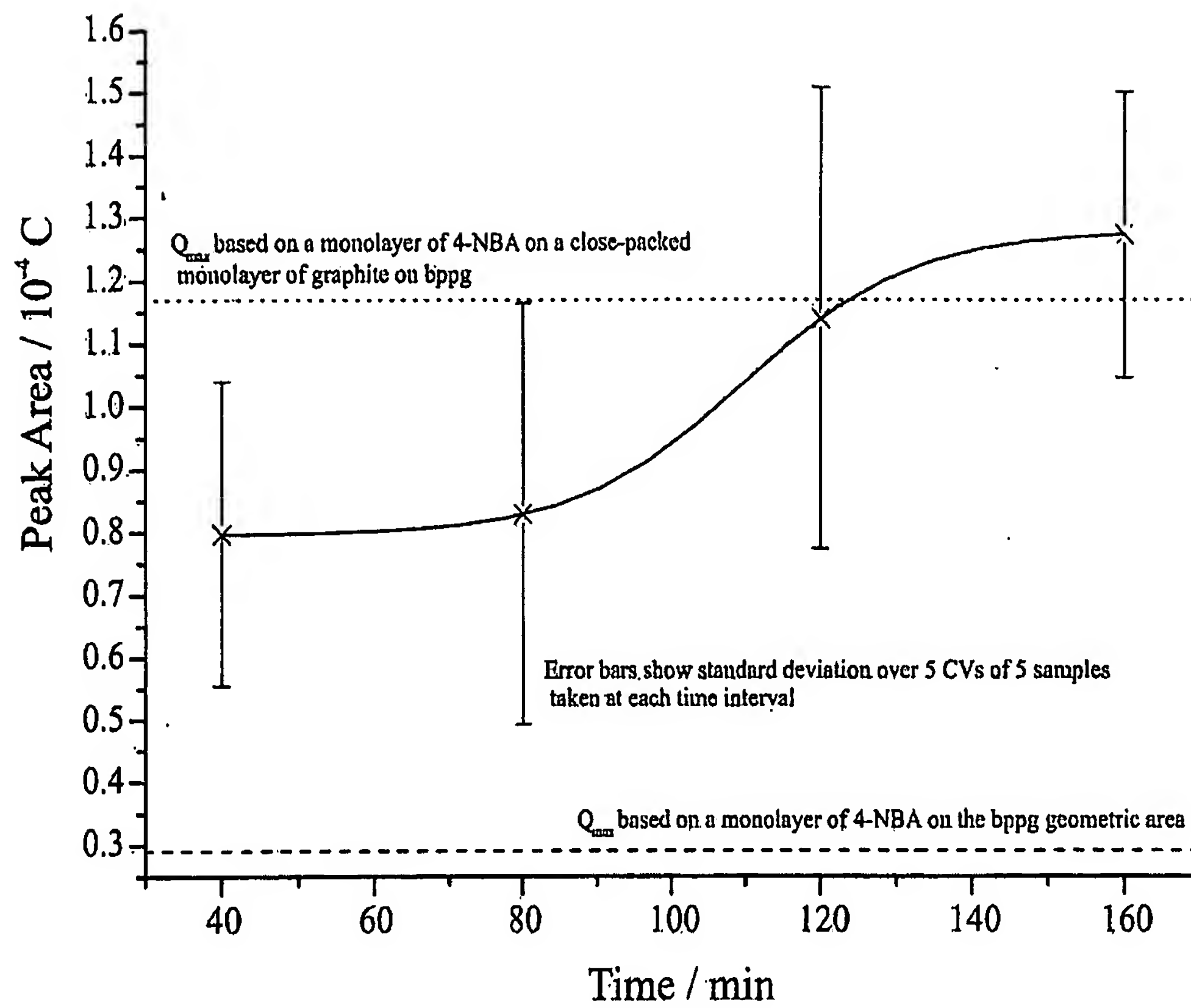


Fig. 18

19/37

Figure 14

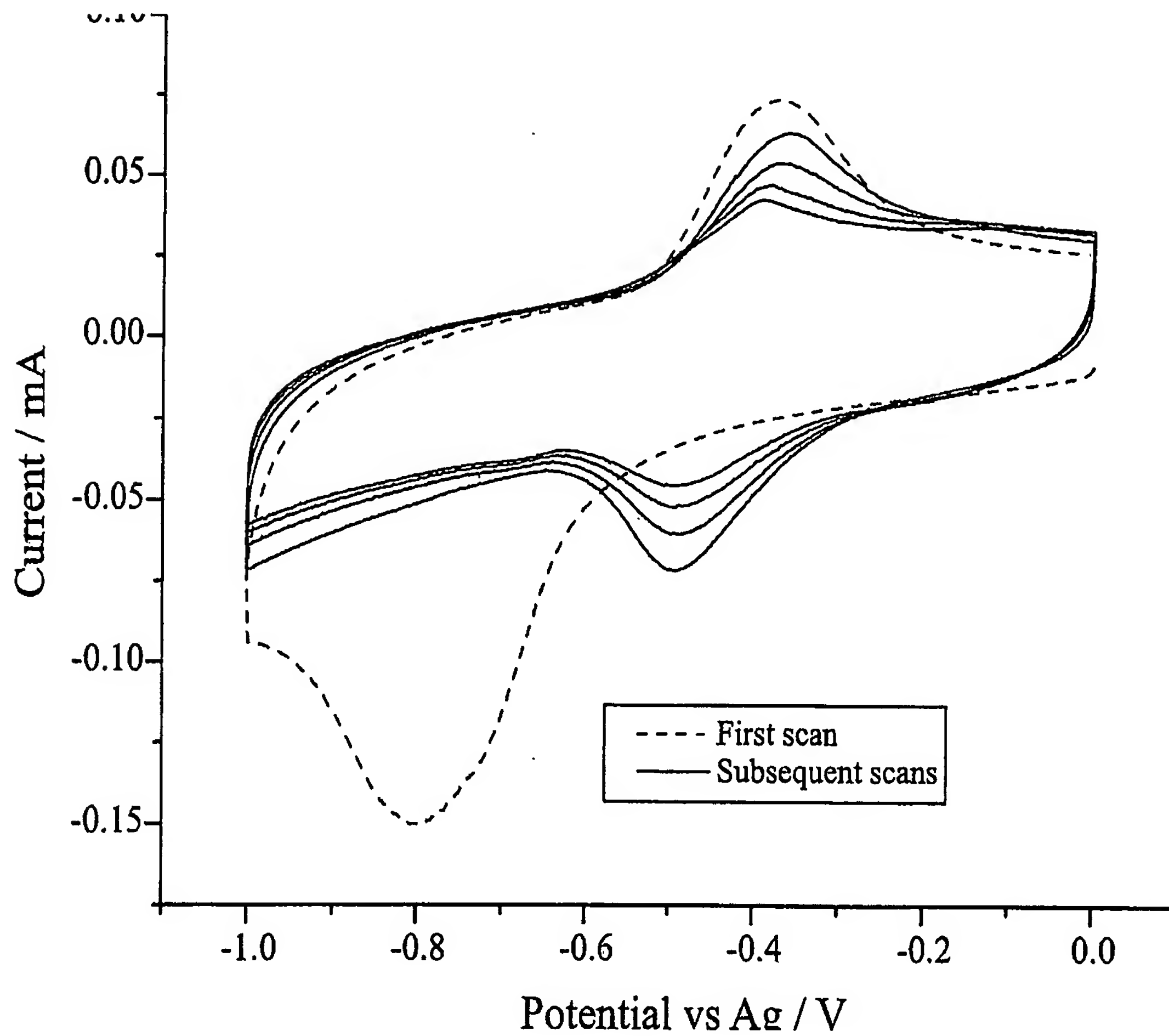


Fig. 19

20/37

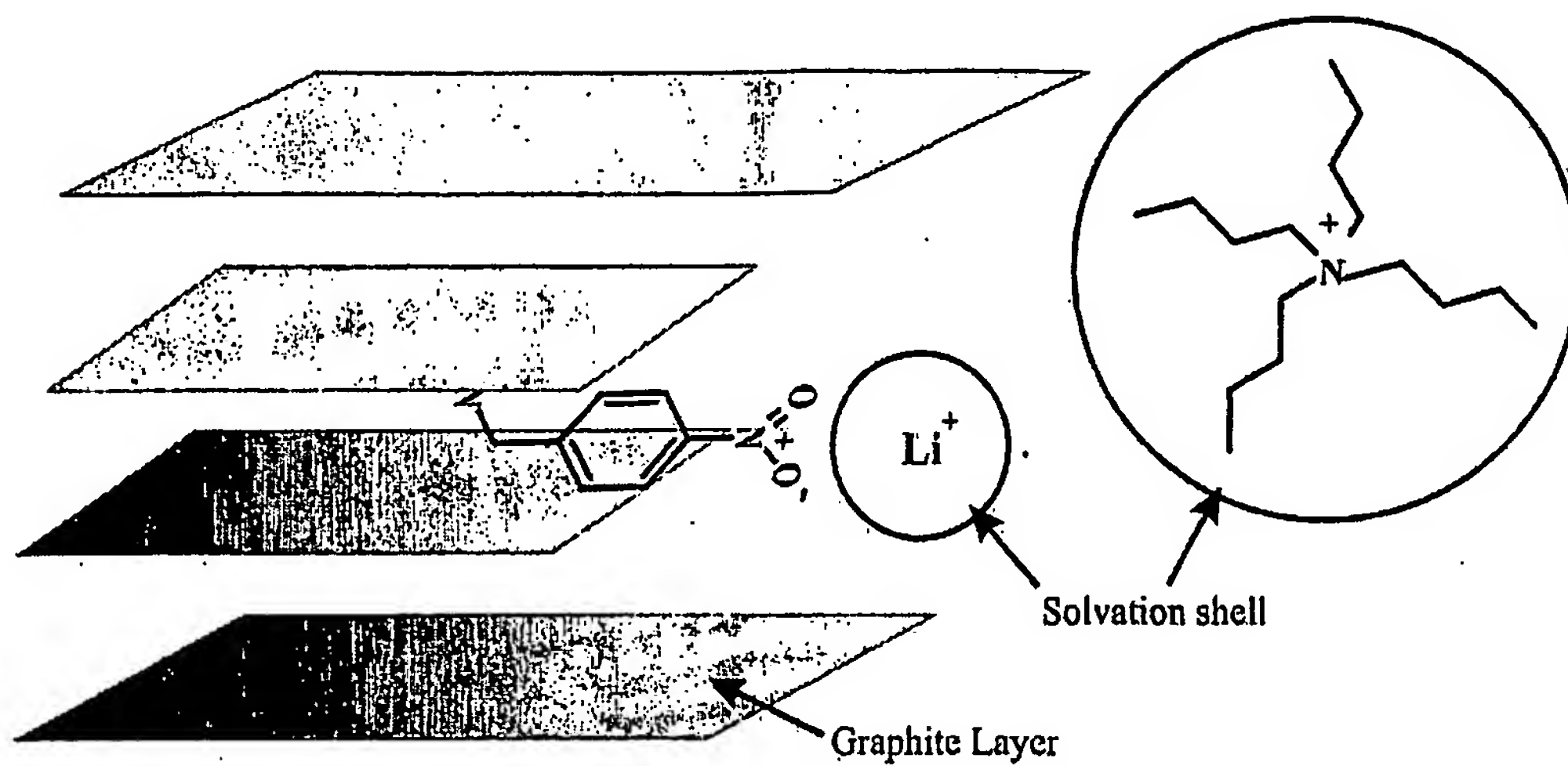


Fig. 20

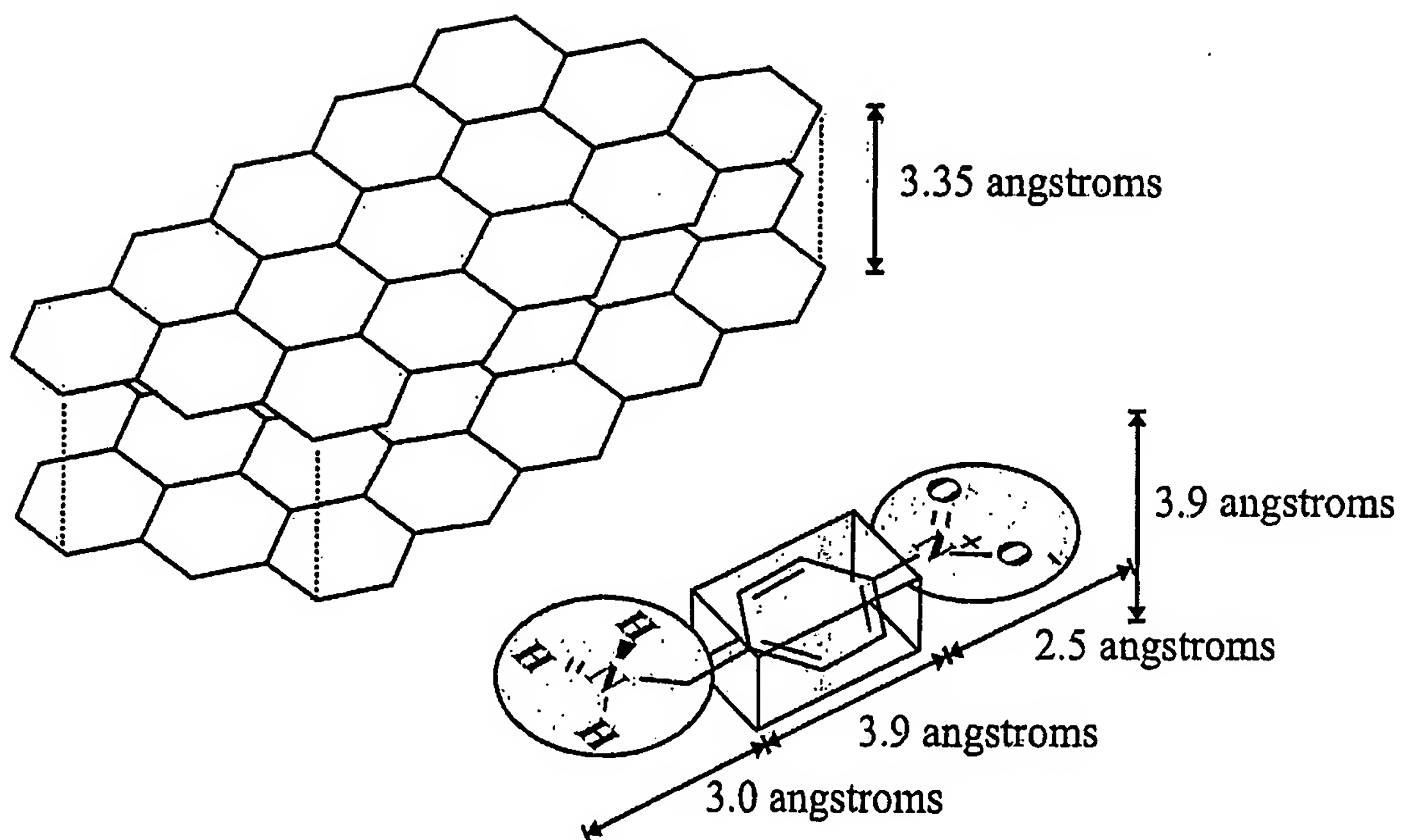


Fig 21

21/37

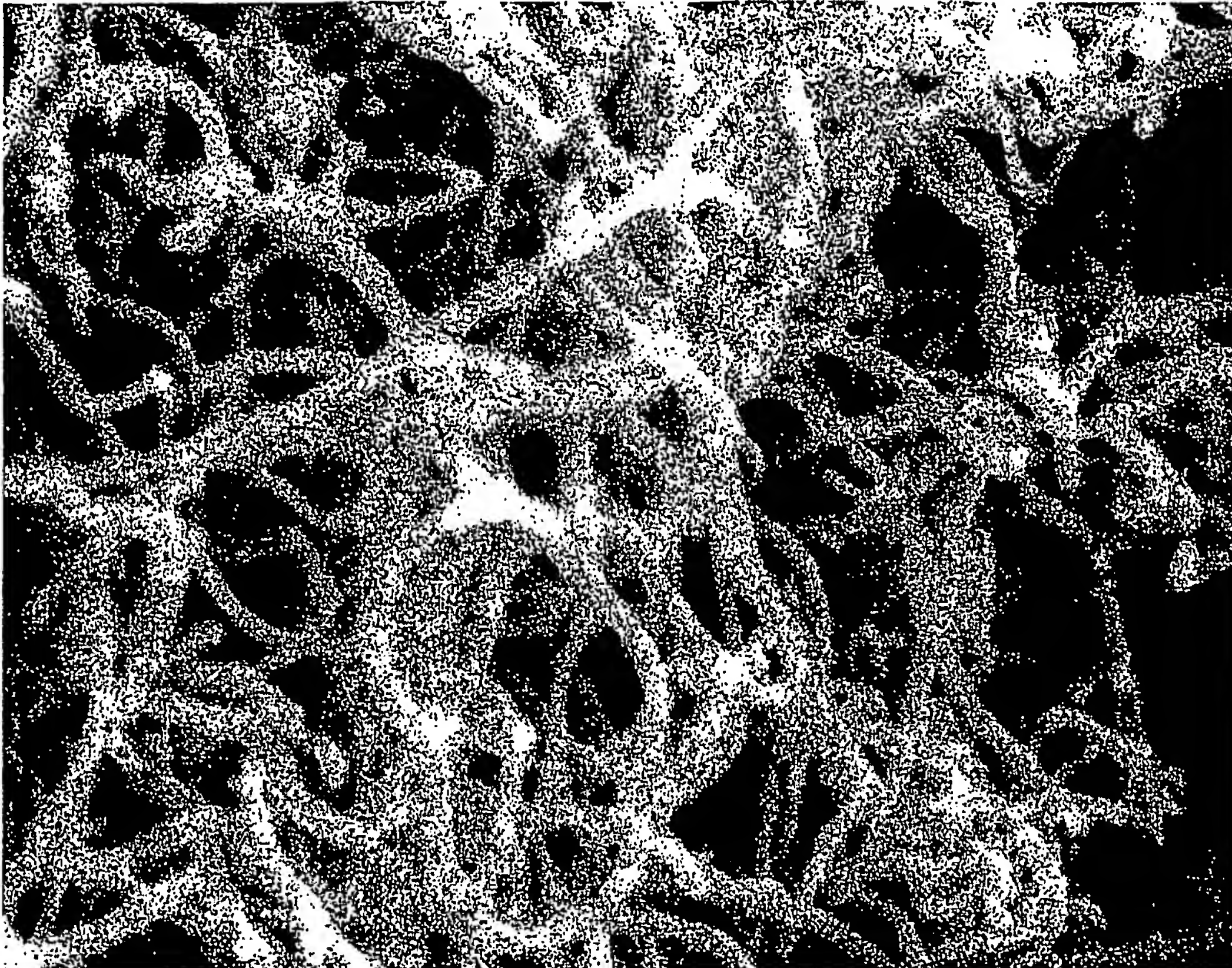


Fig. 22a

22/37

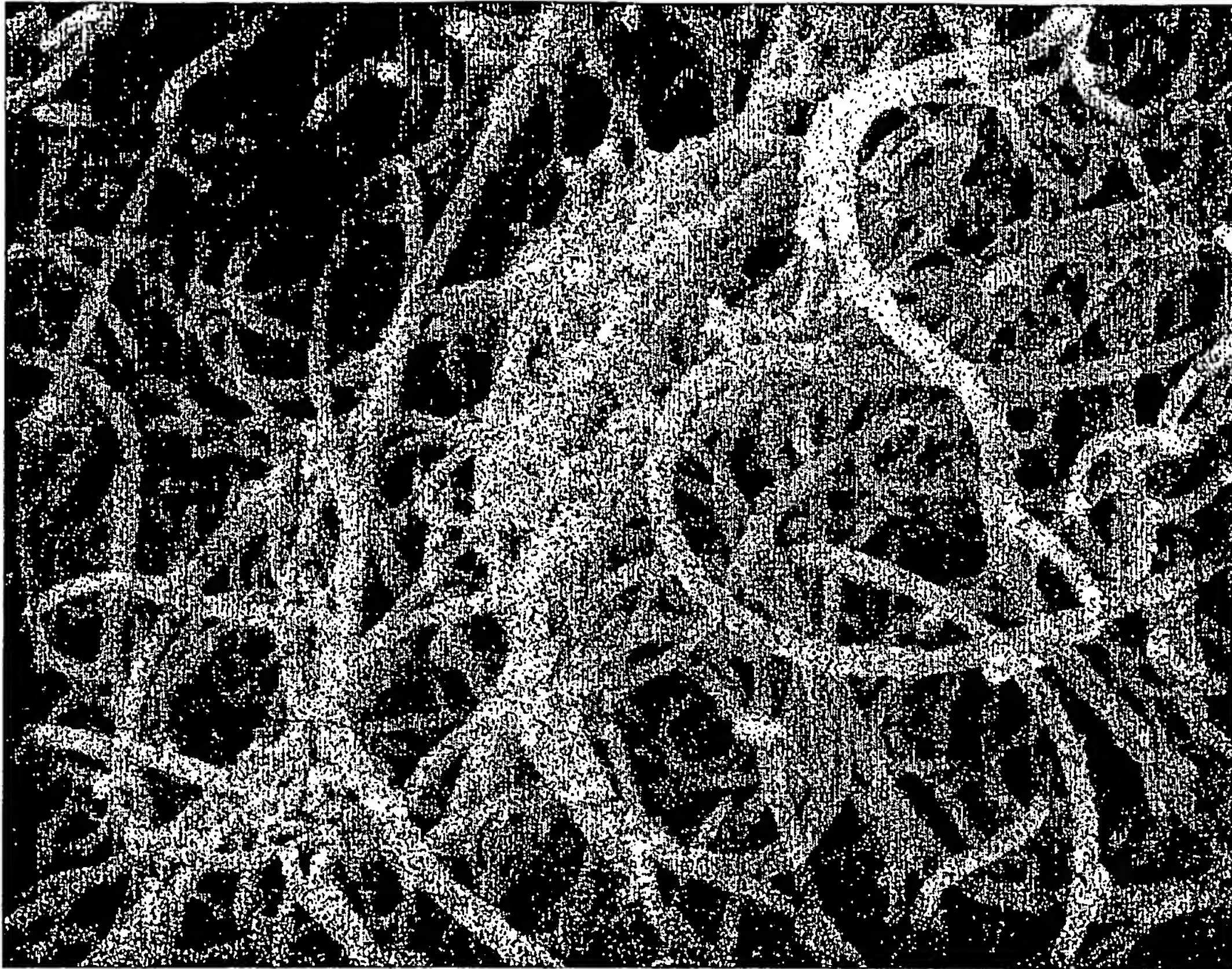


Fig. 22b

23/37

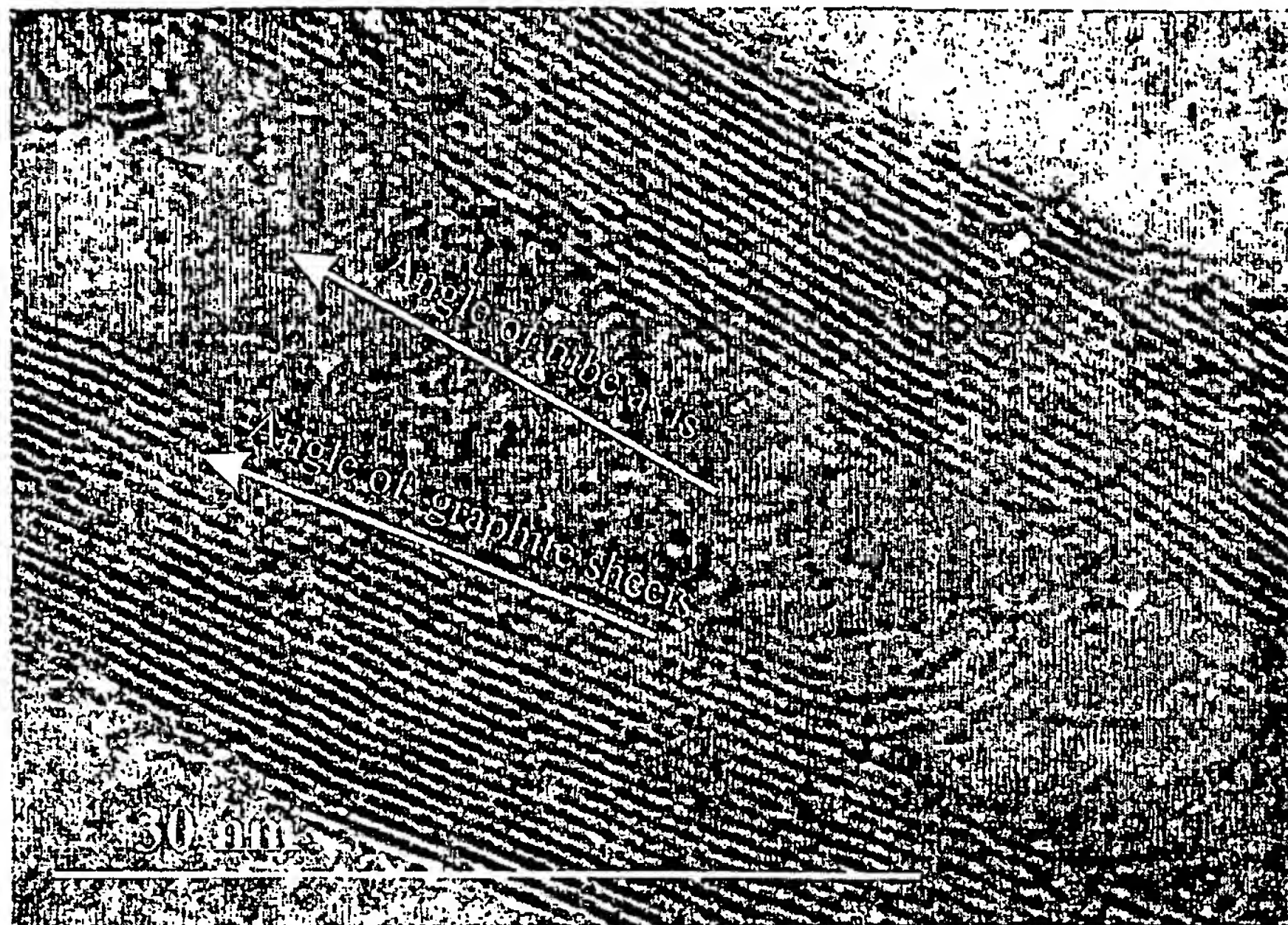


Fig. 23a

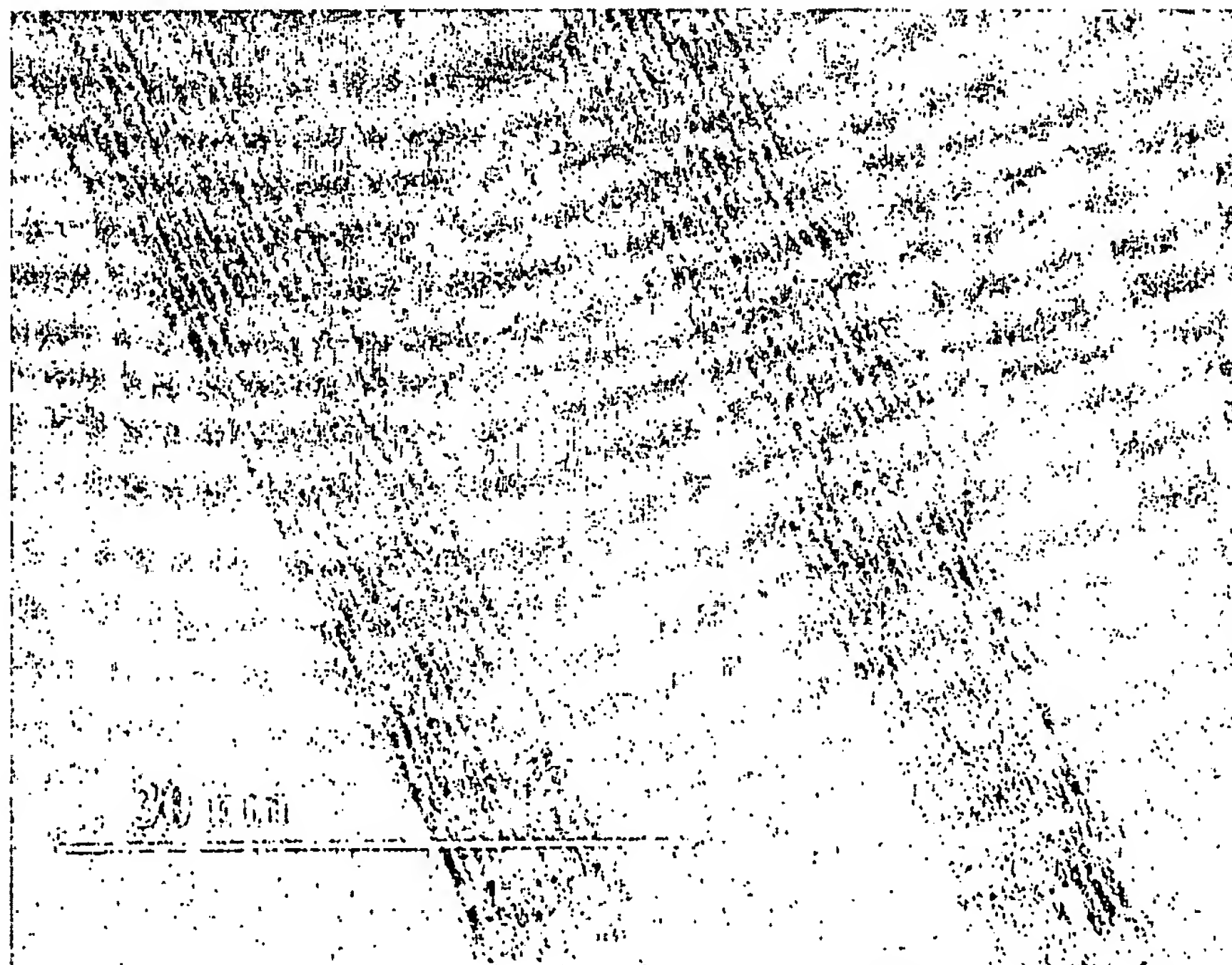


Fig. 23b

24/37

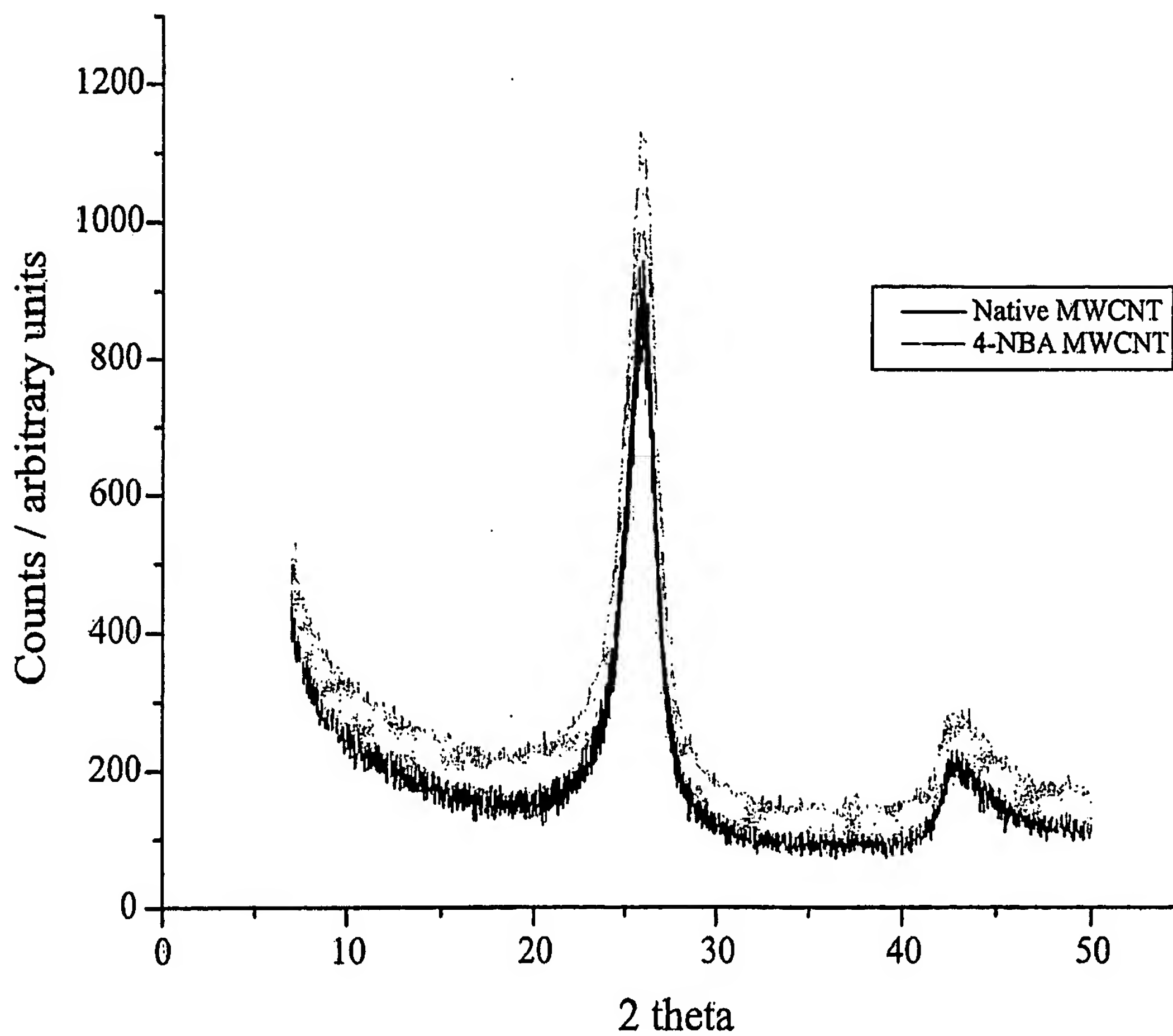


Fig. 24

25/37

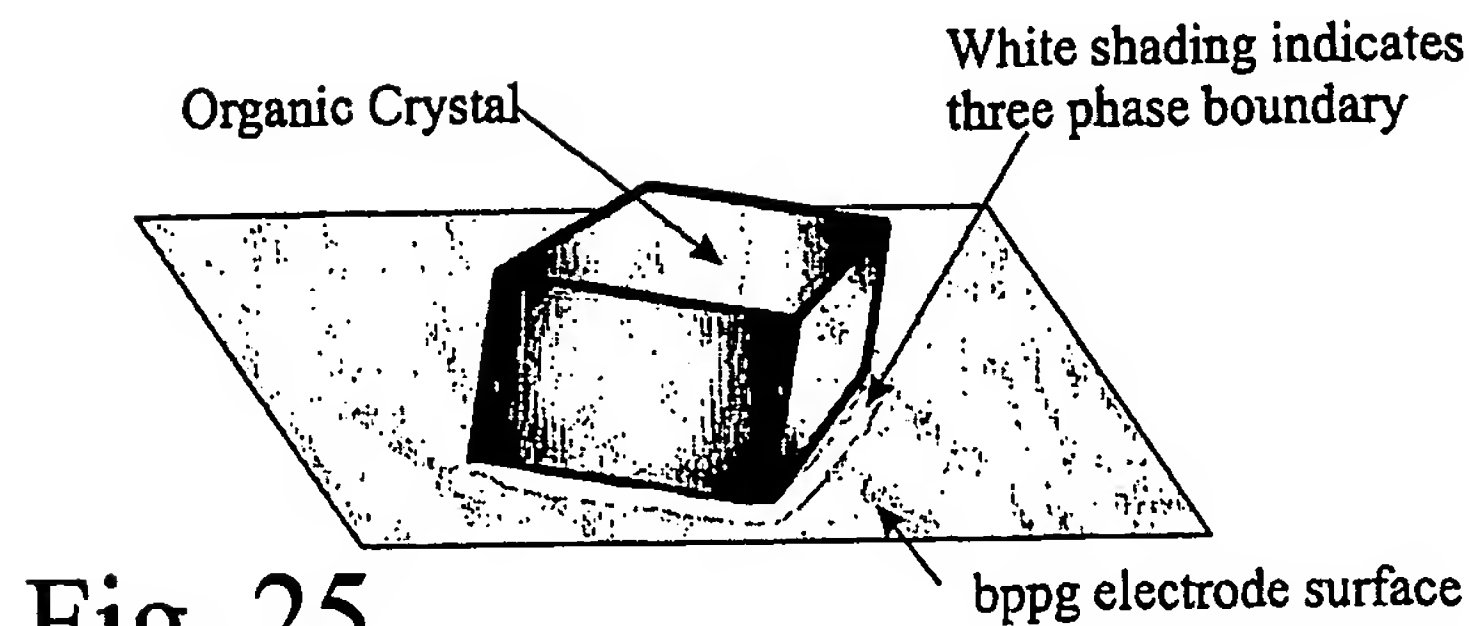


Fig. 25

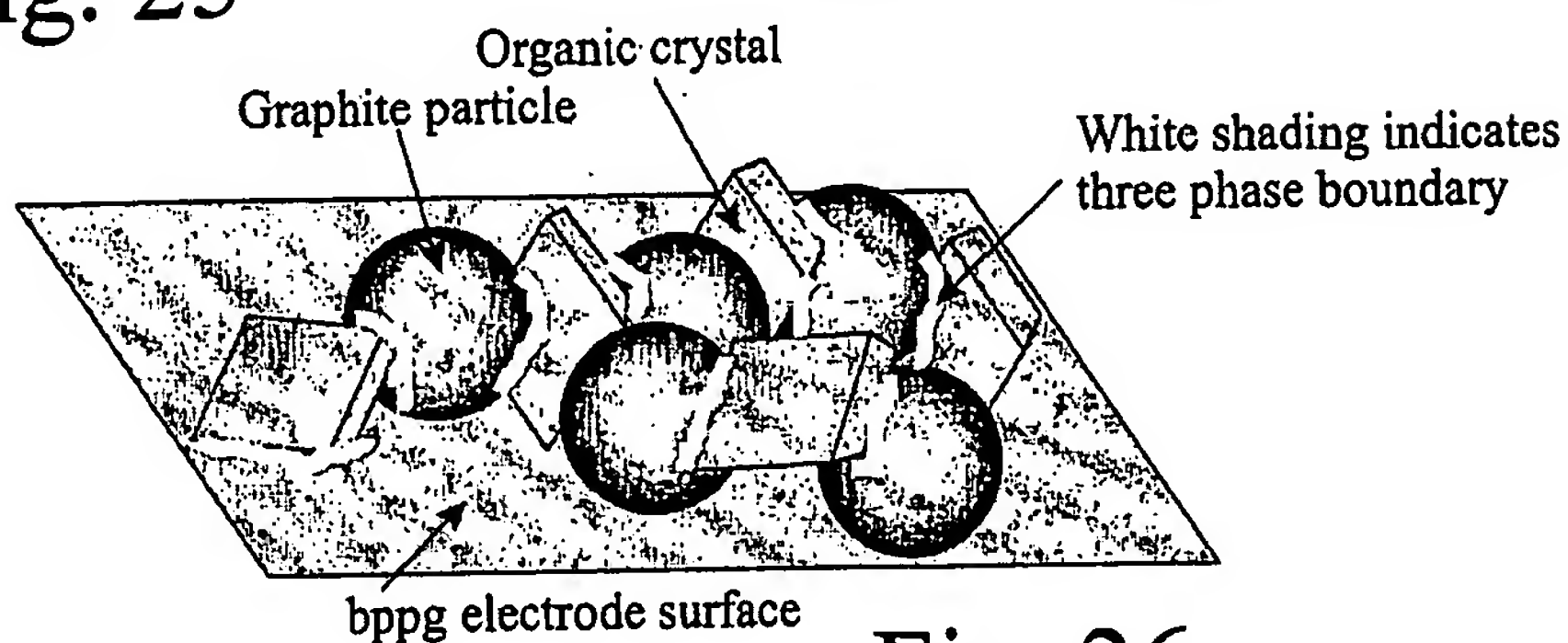


Fig. 26

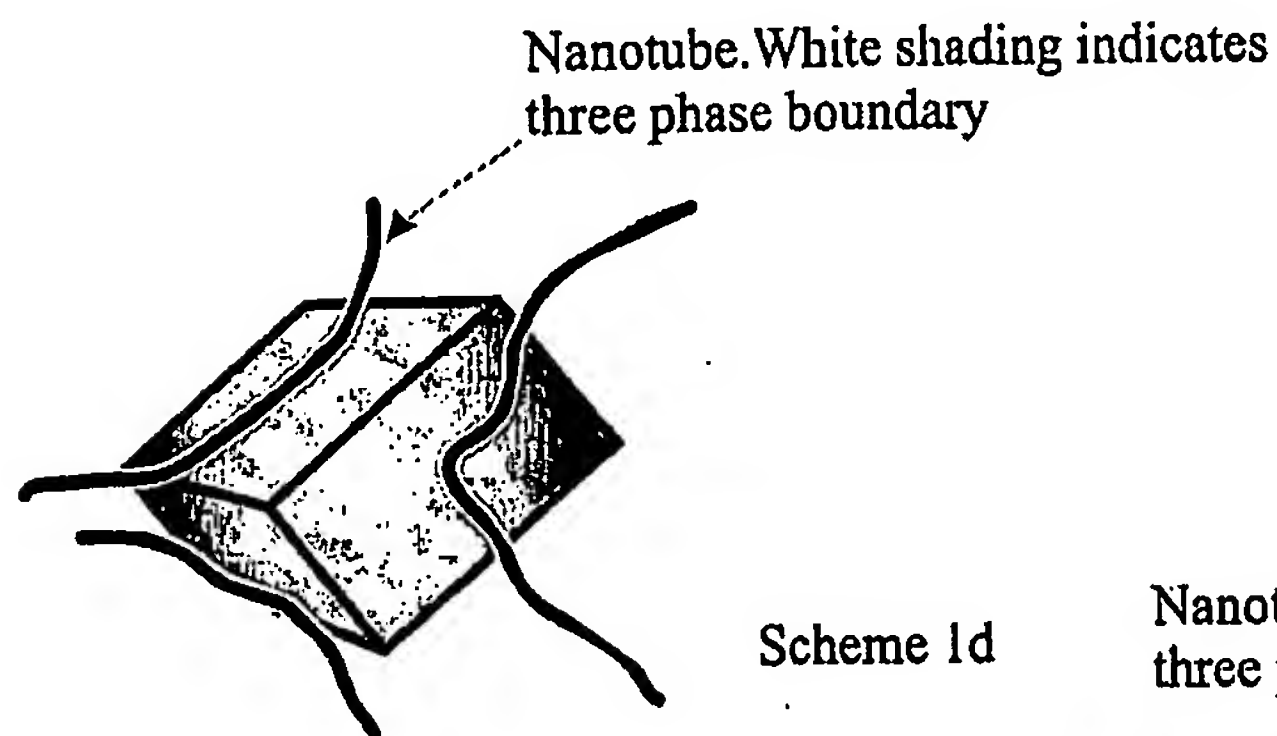


Fig. 27

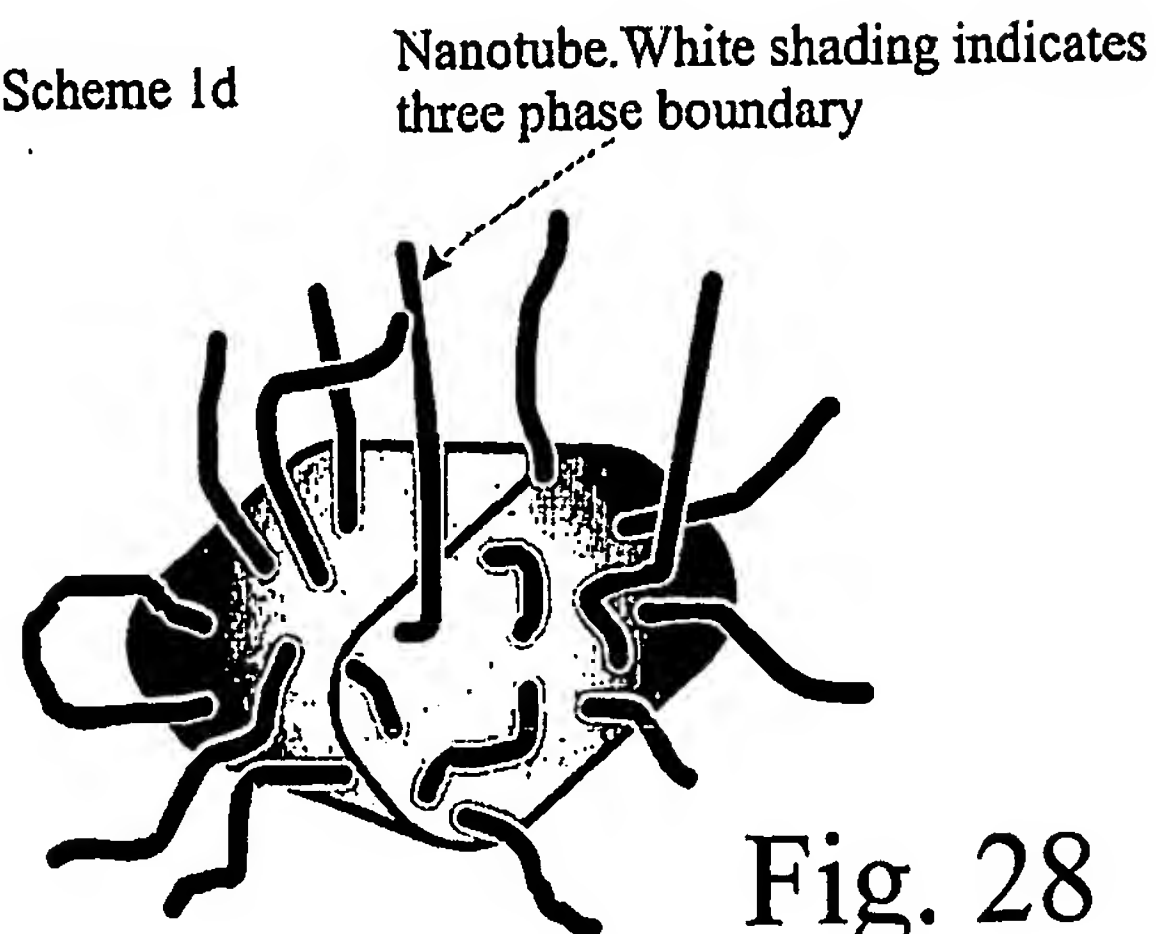


Fig. 28

26/37

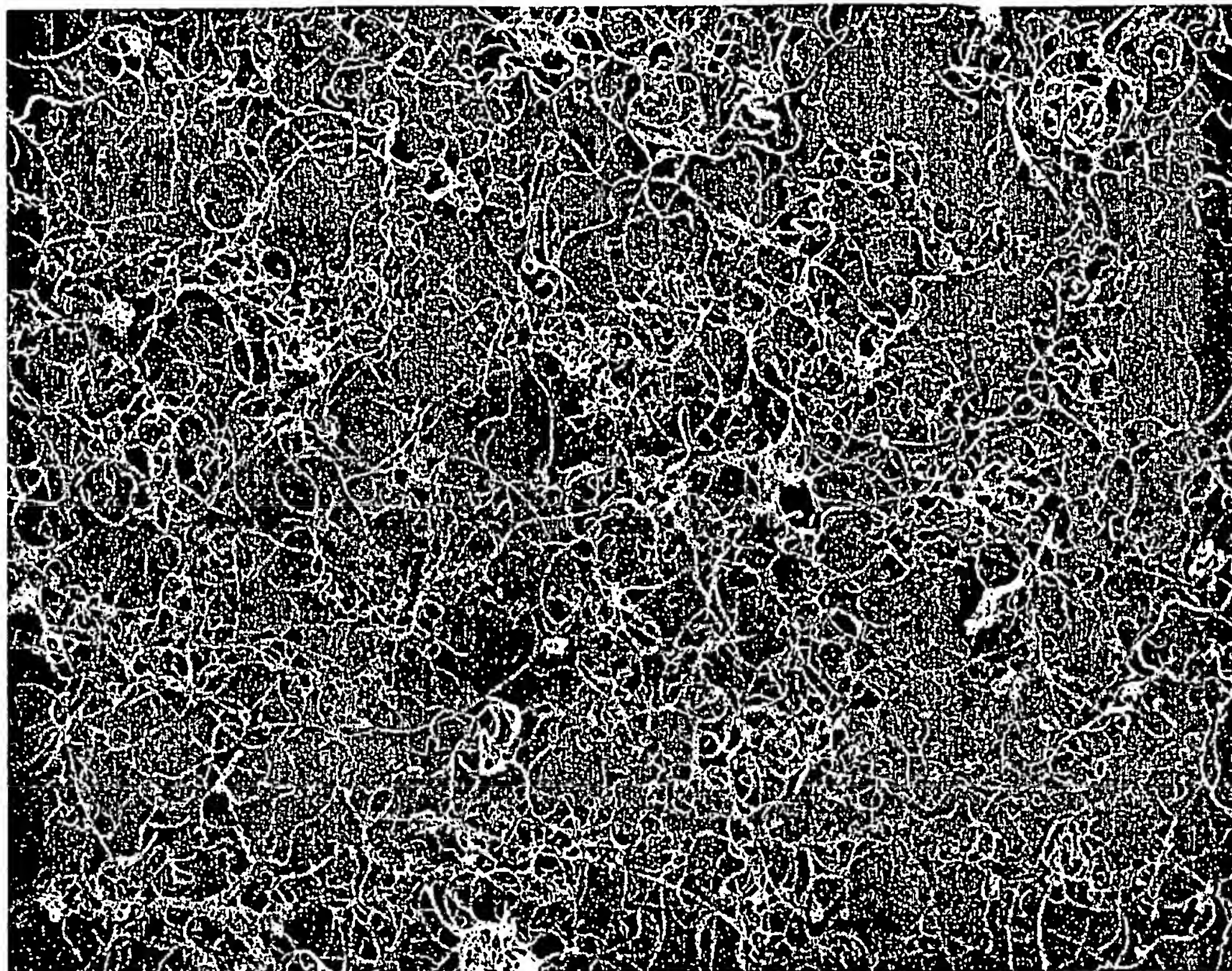


Fig. 29

27/37

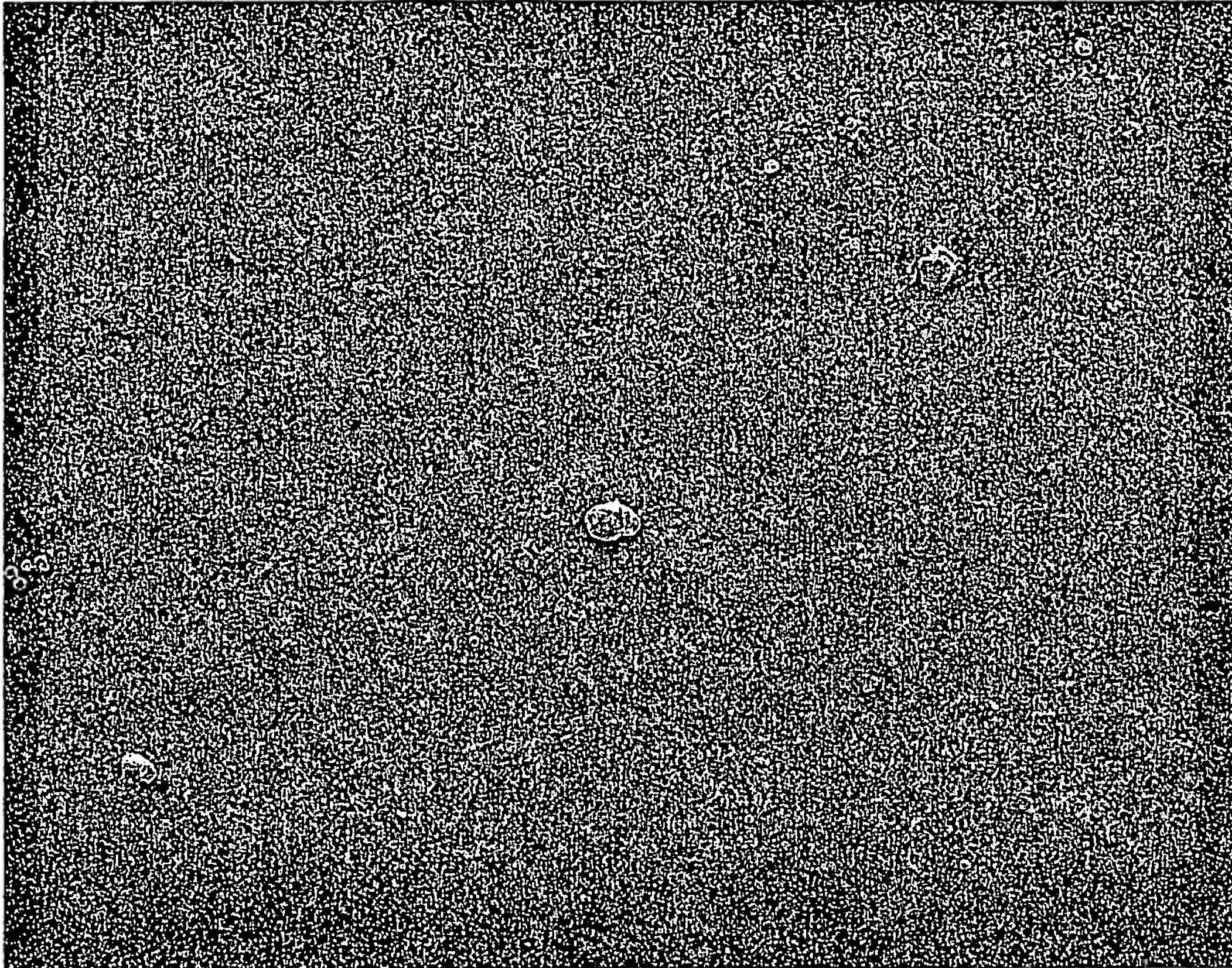


Fig. 30

28/37

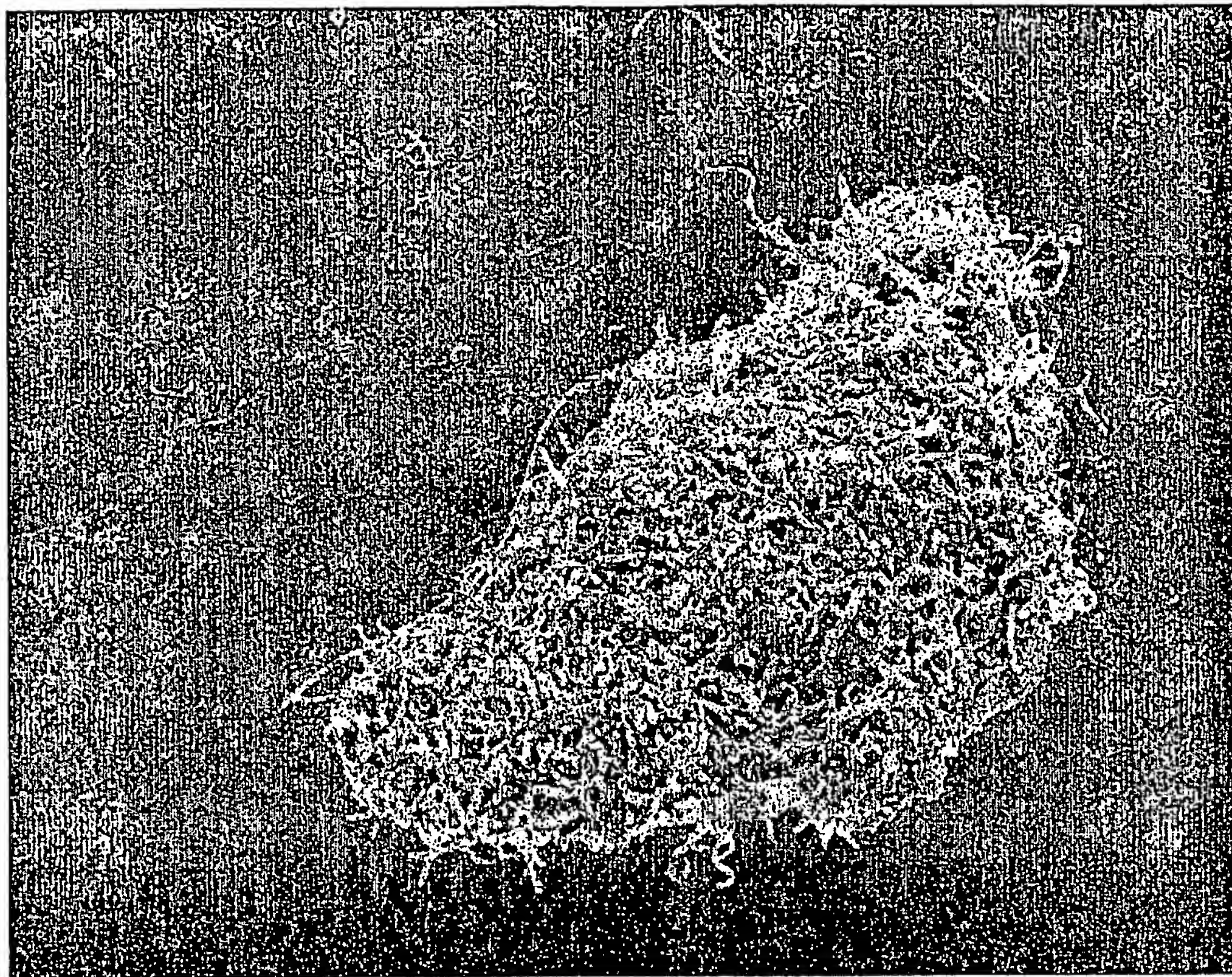


Fig. 31

29/37



Fig. 32

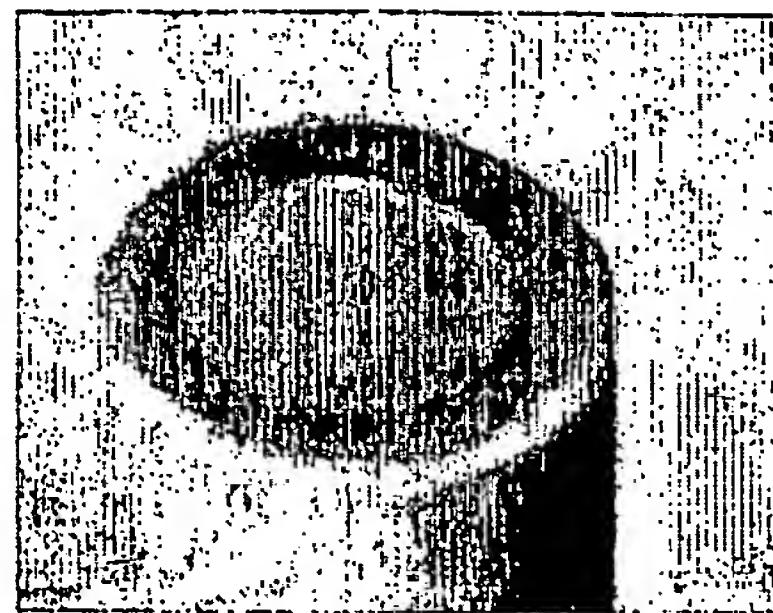


Fig. 33

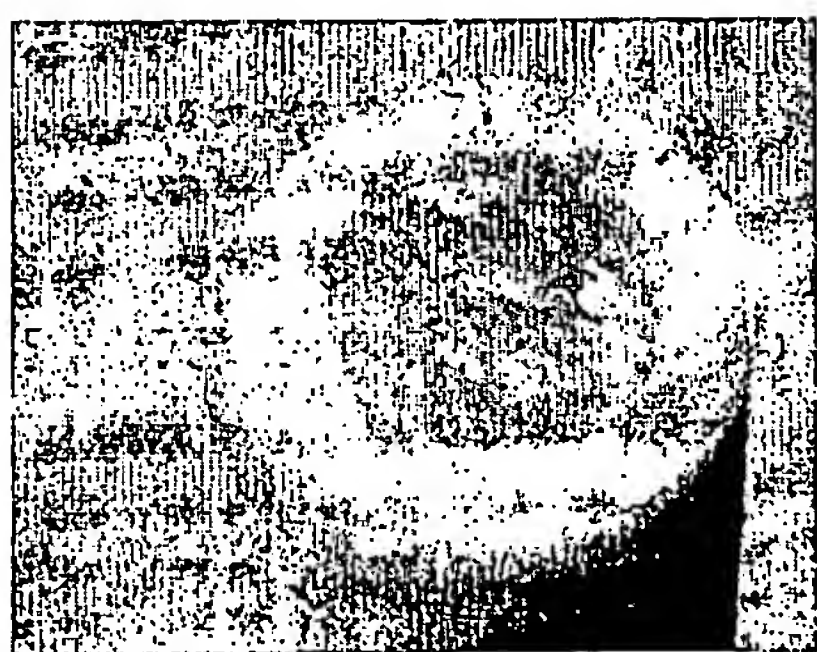


Fig. 34

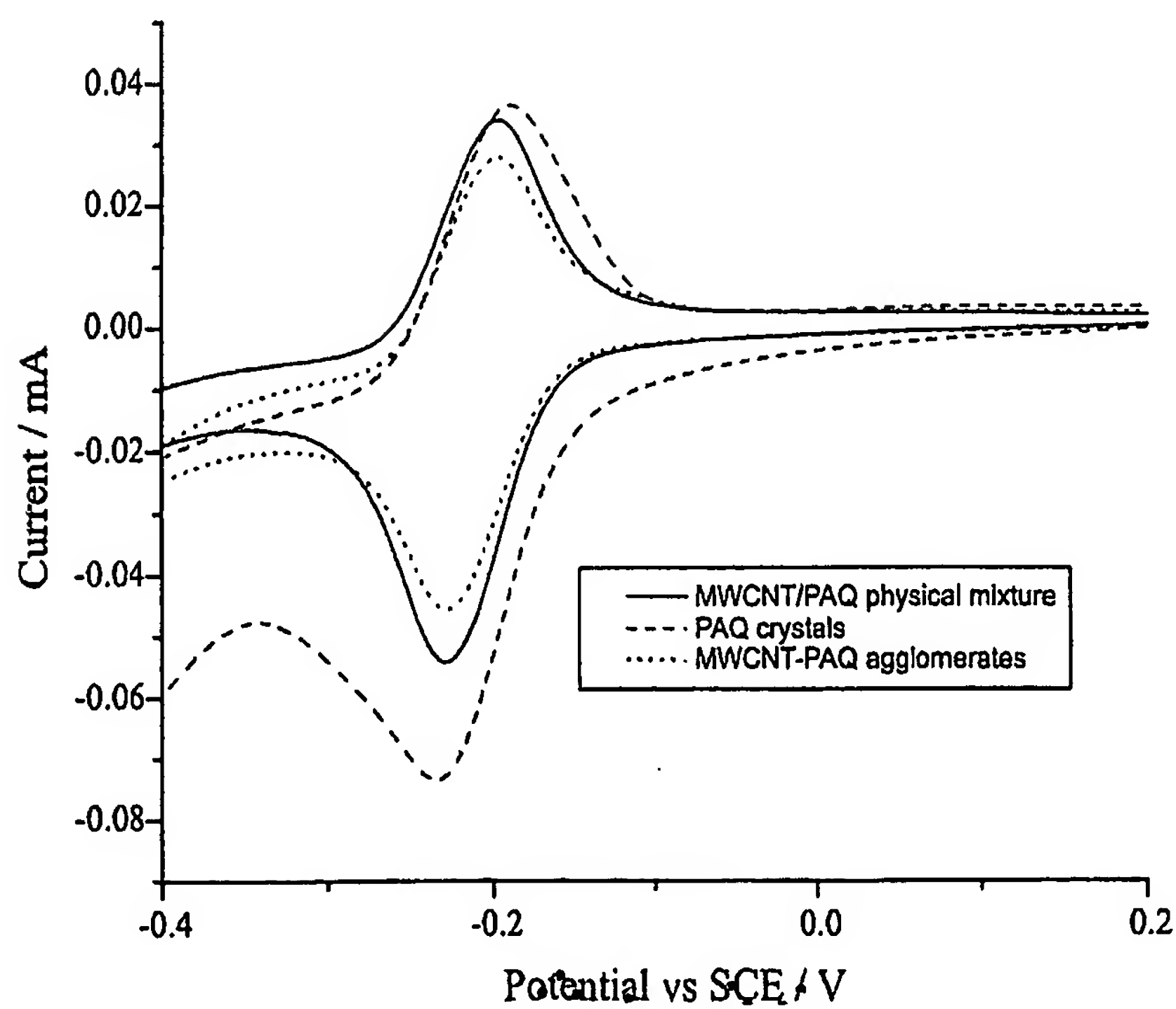


Fig. 35

30/37

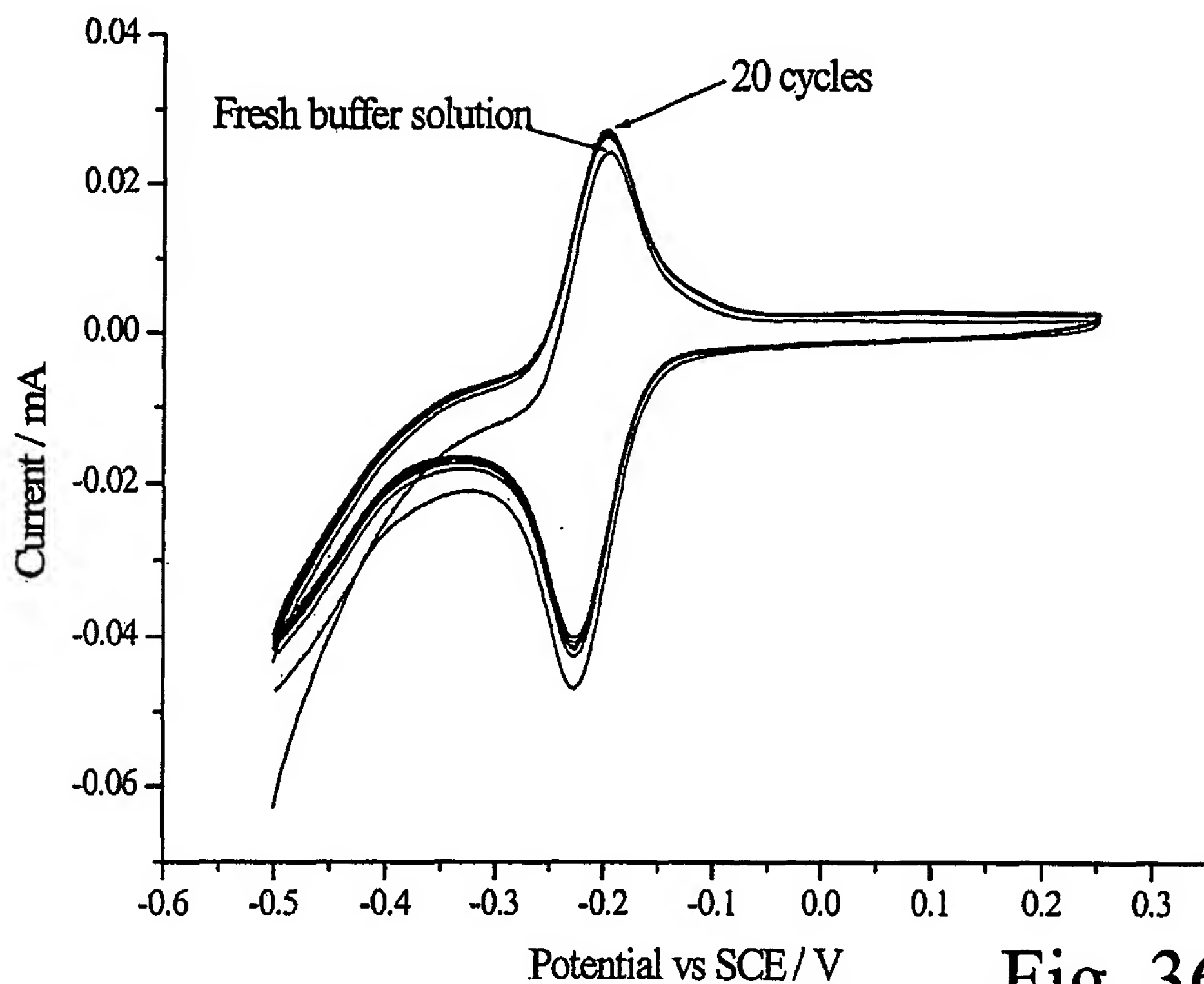


Fig. 36a

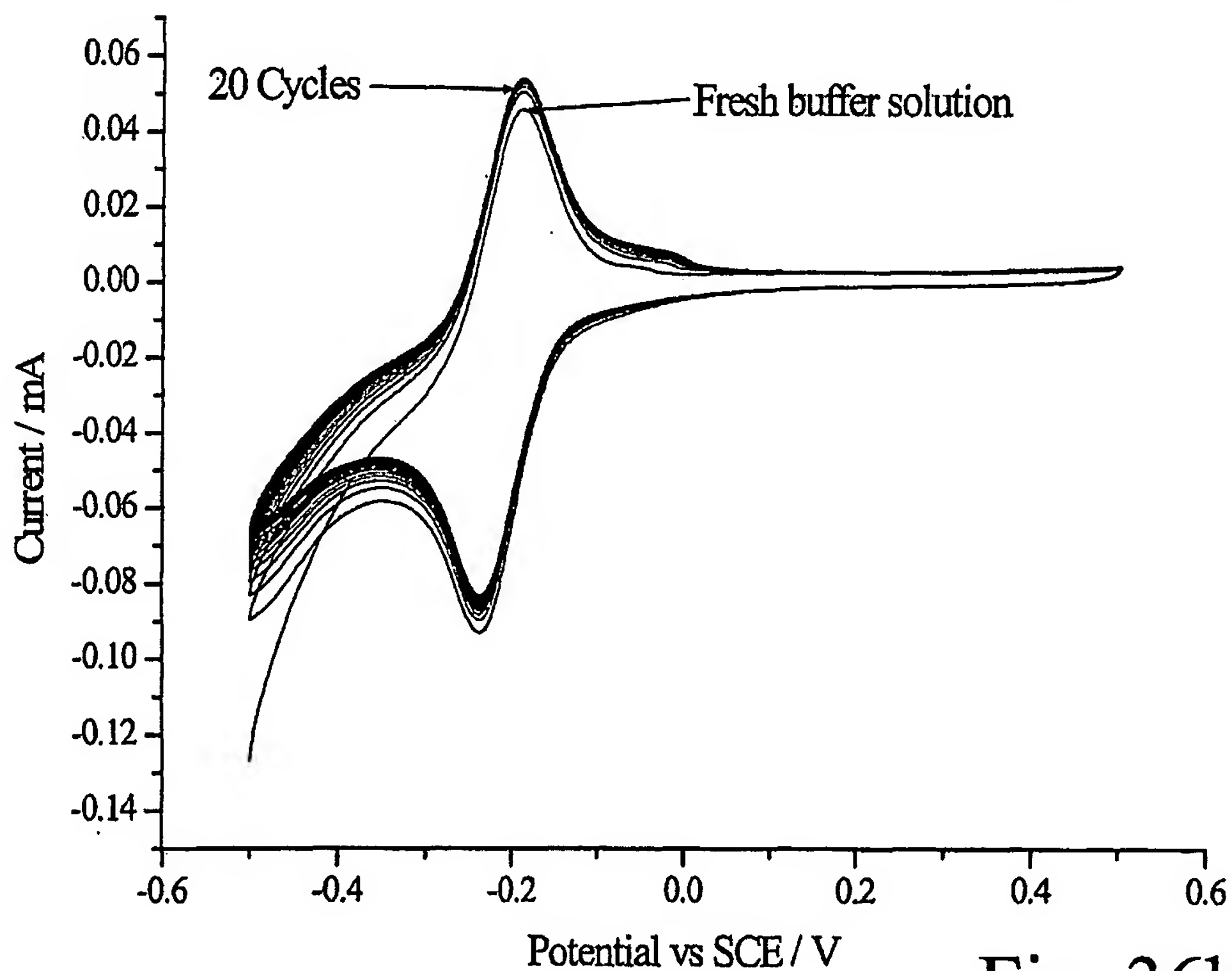


Fig. 36b

31/37

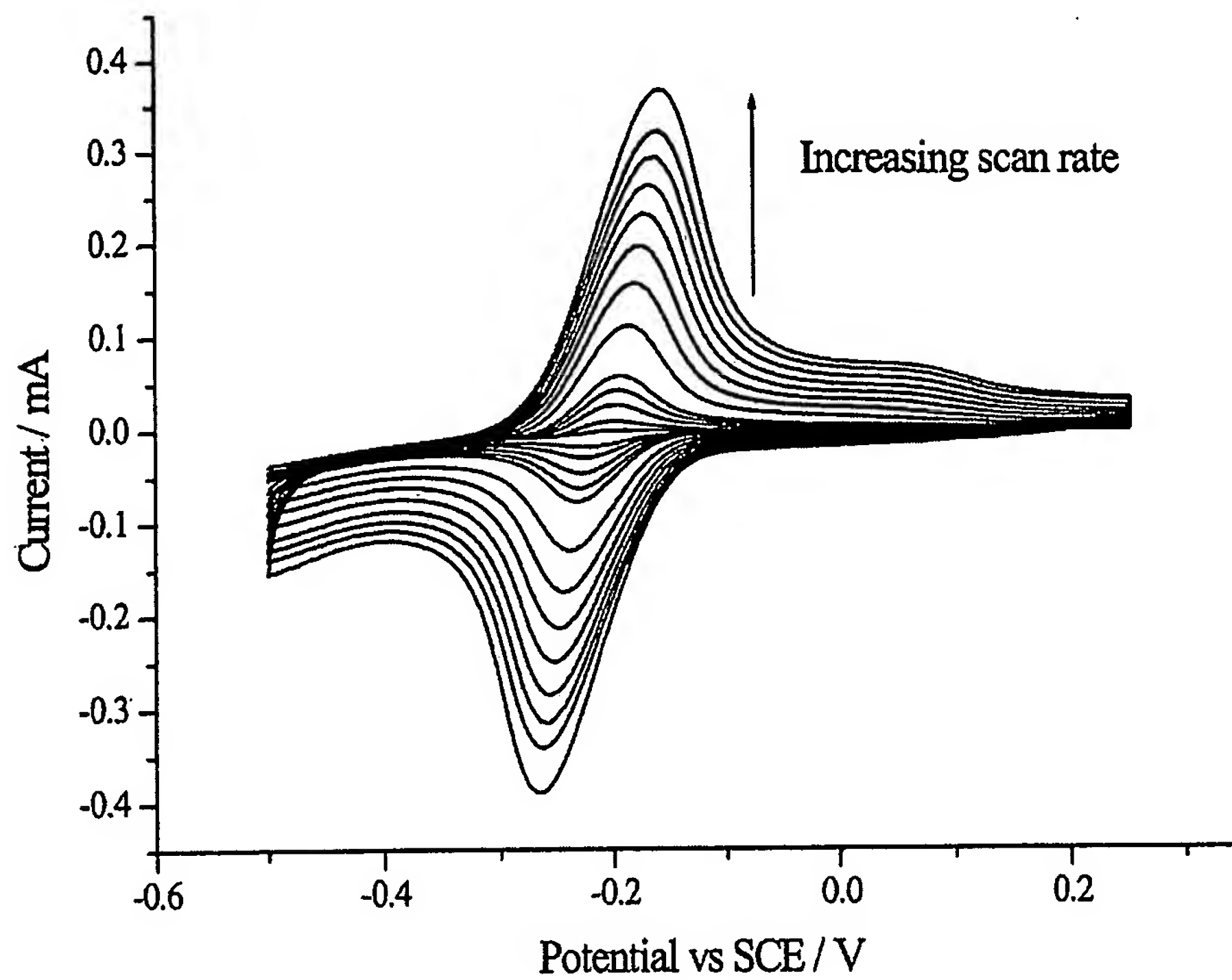
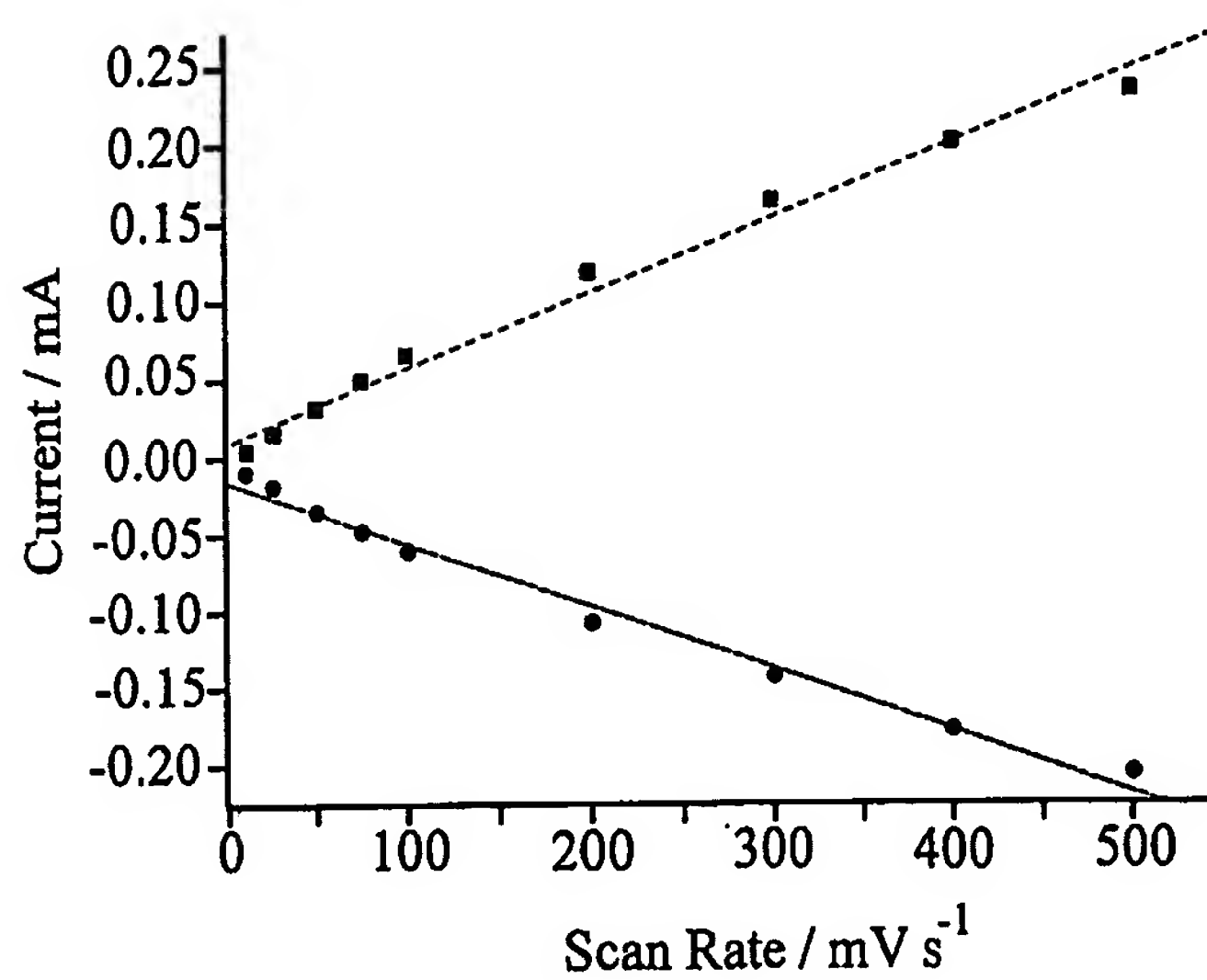


Fig. 37a



32/37

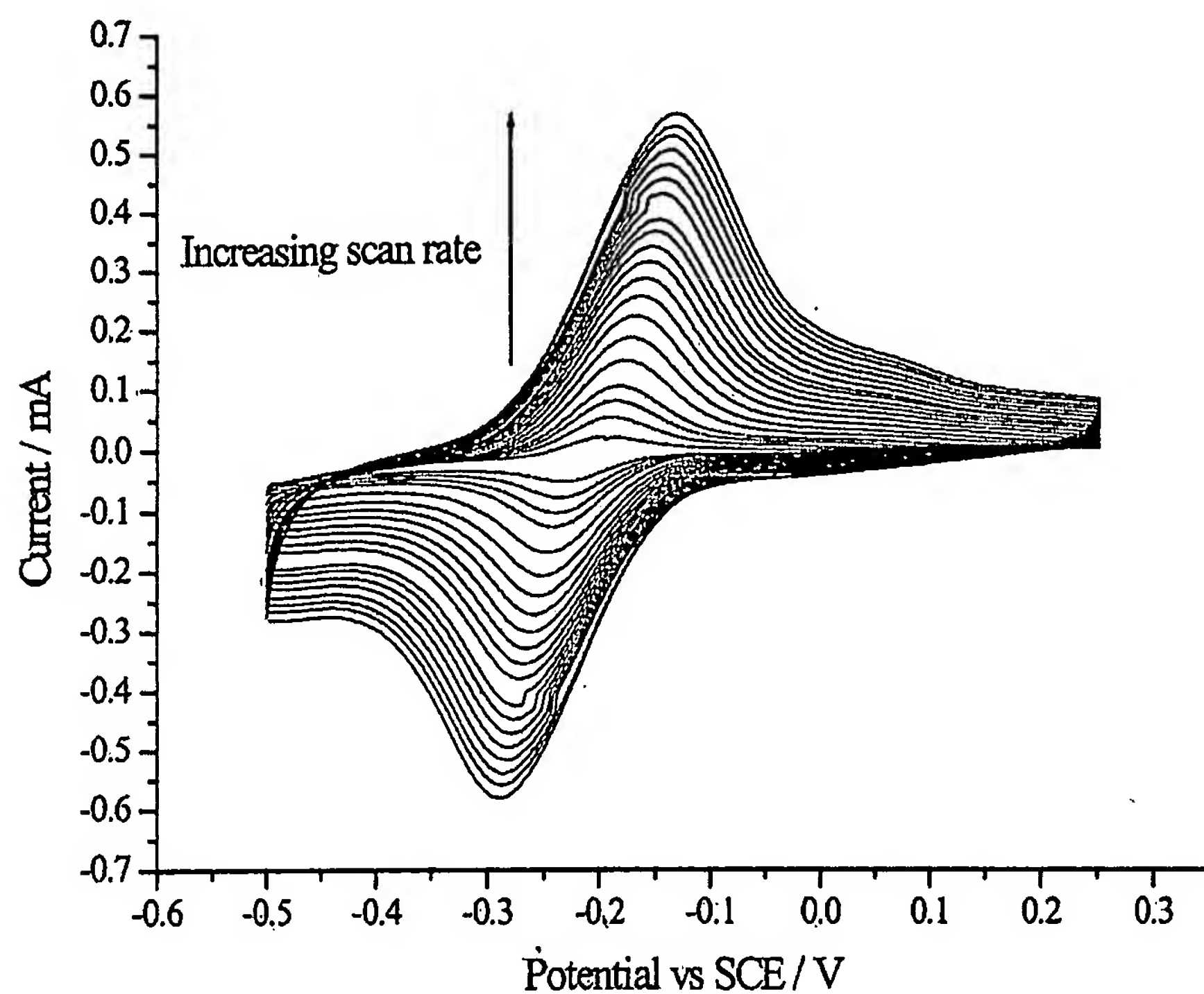
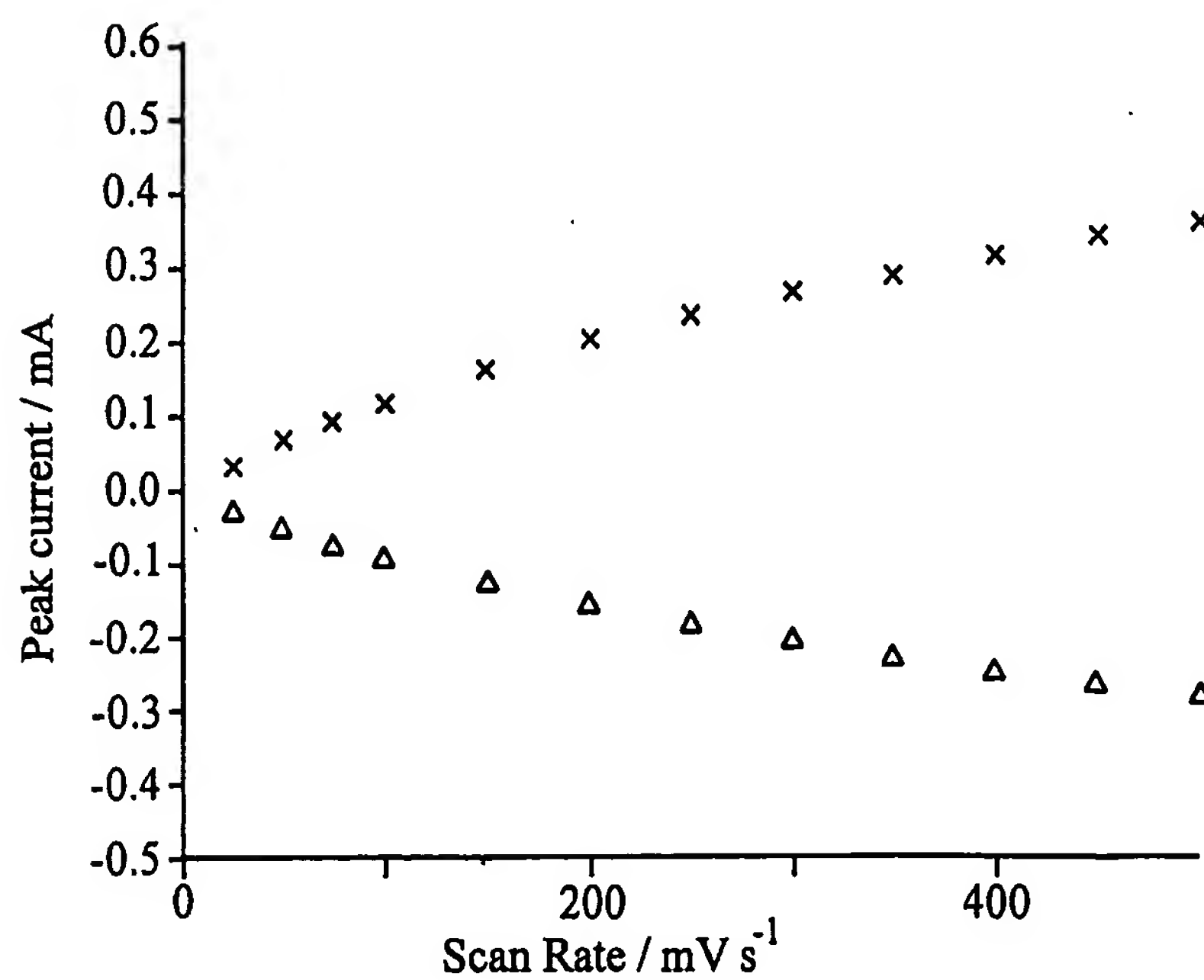


Fig. 37b



33/37

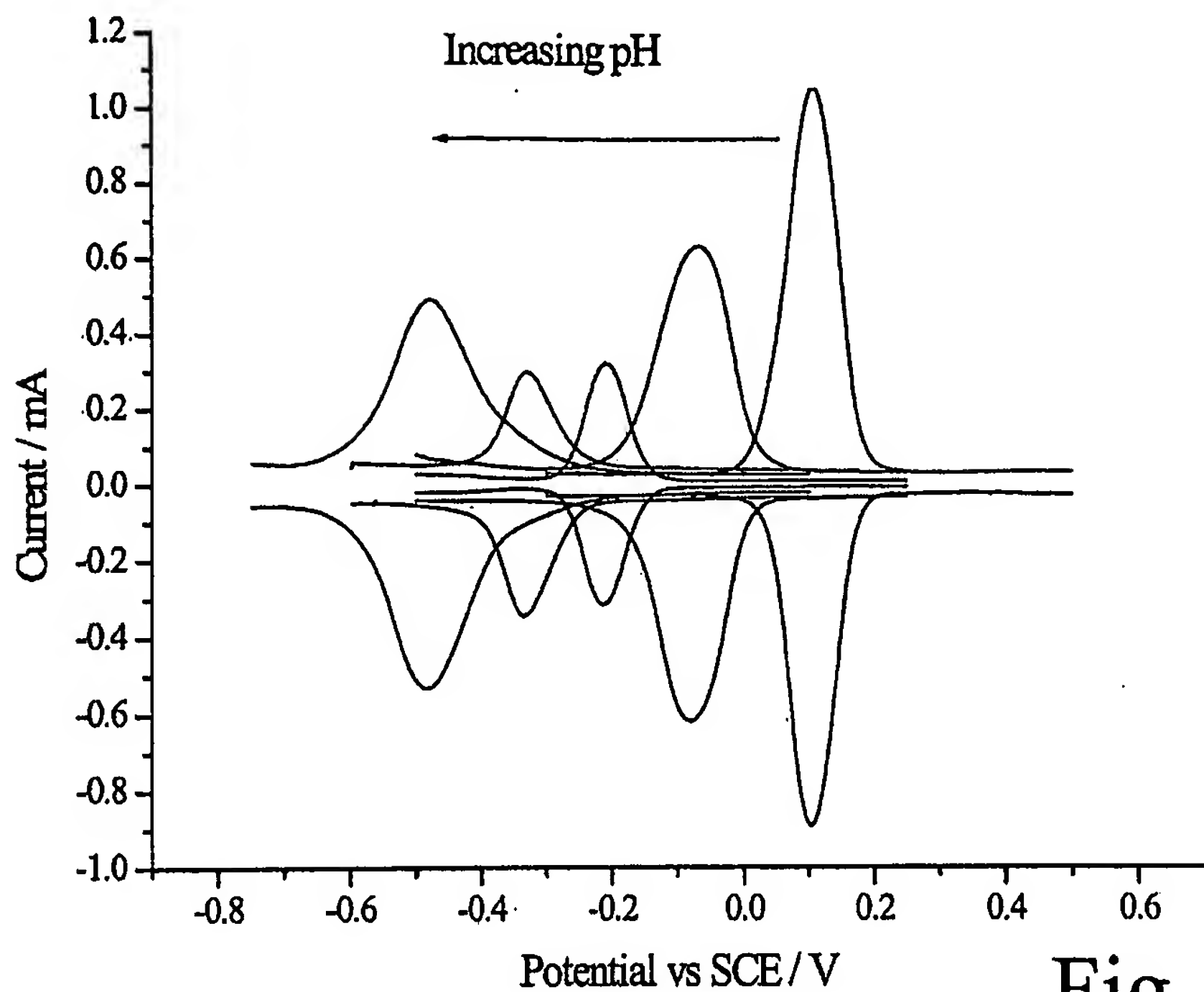


Fig. 38a

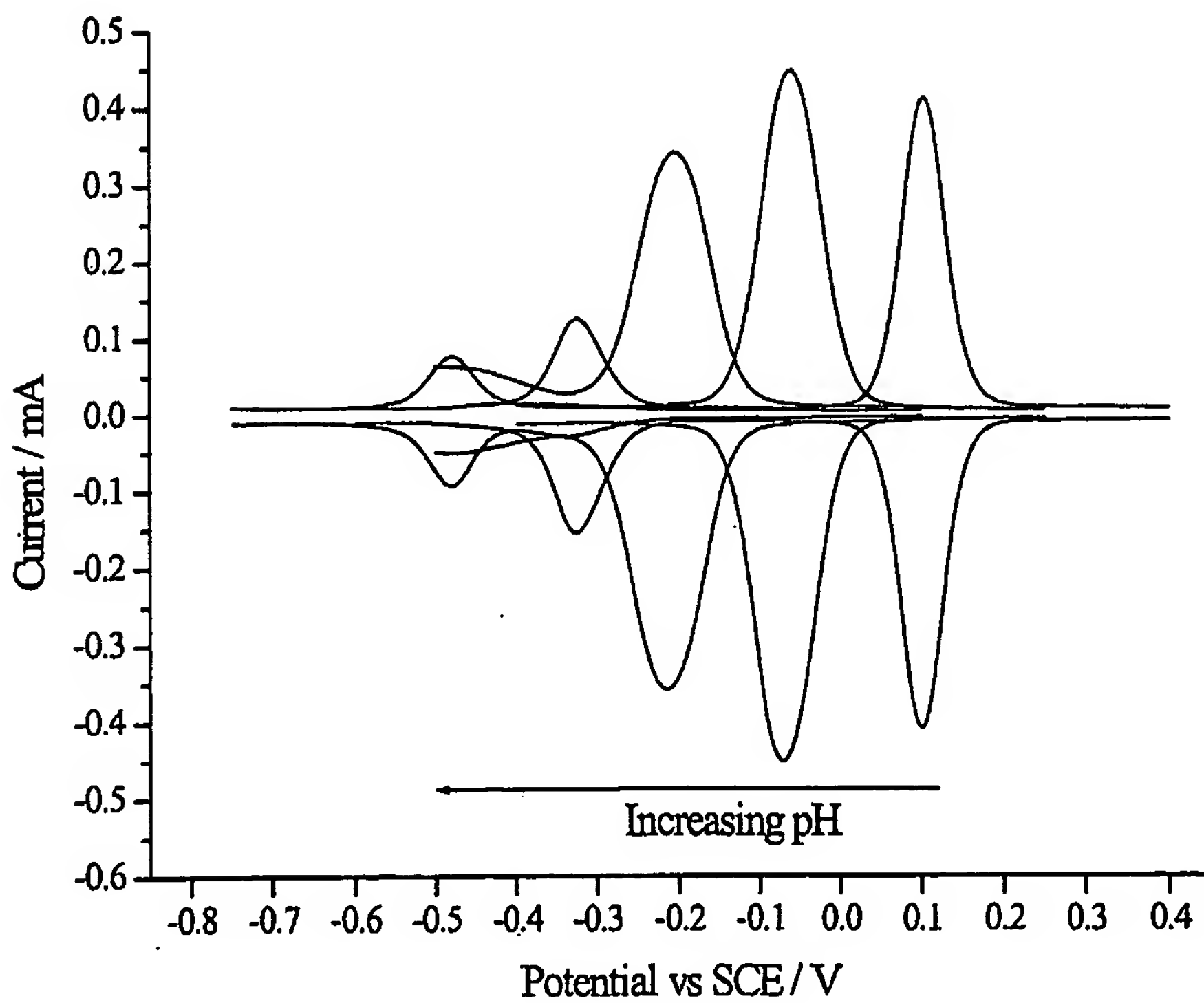


Fig. 38b

34/37

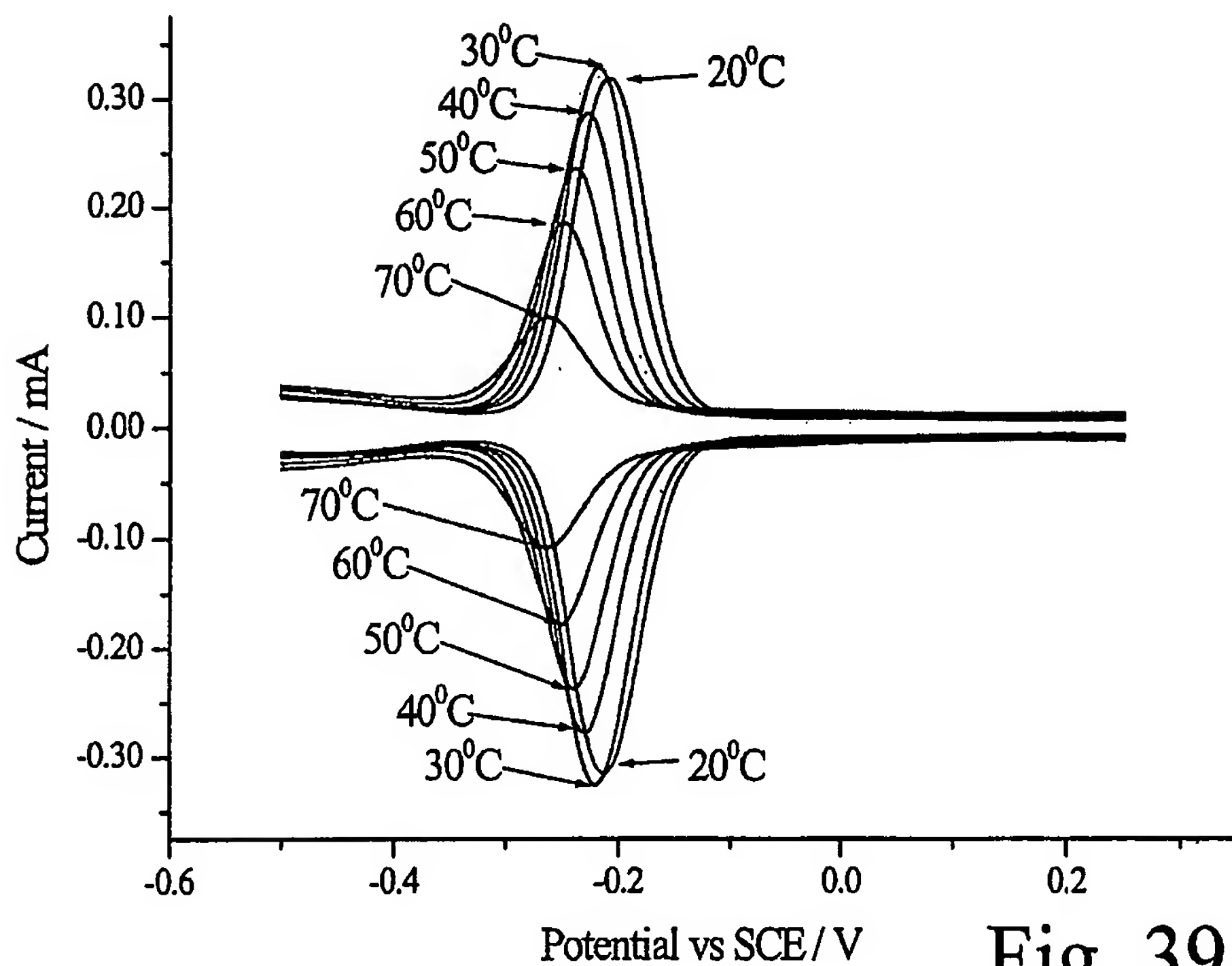


Fig. 39a

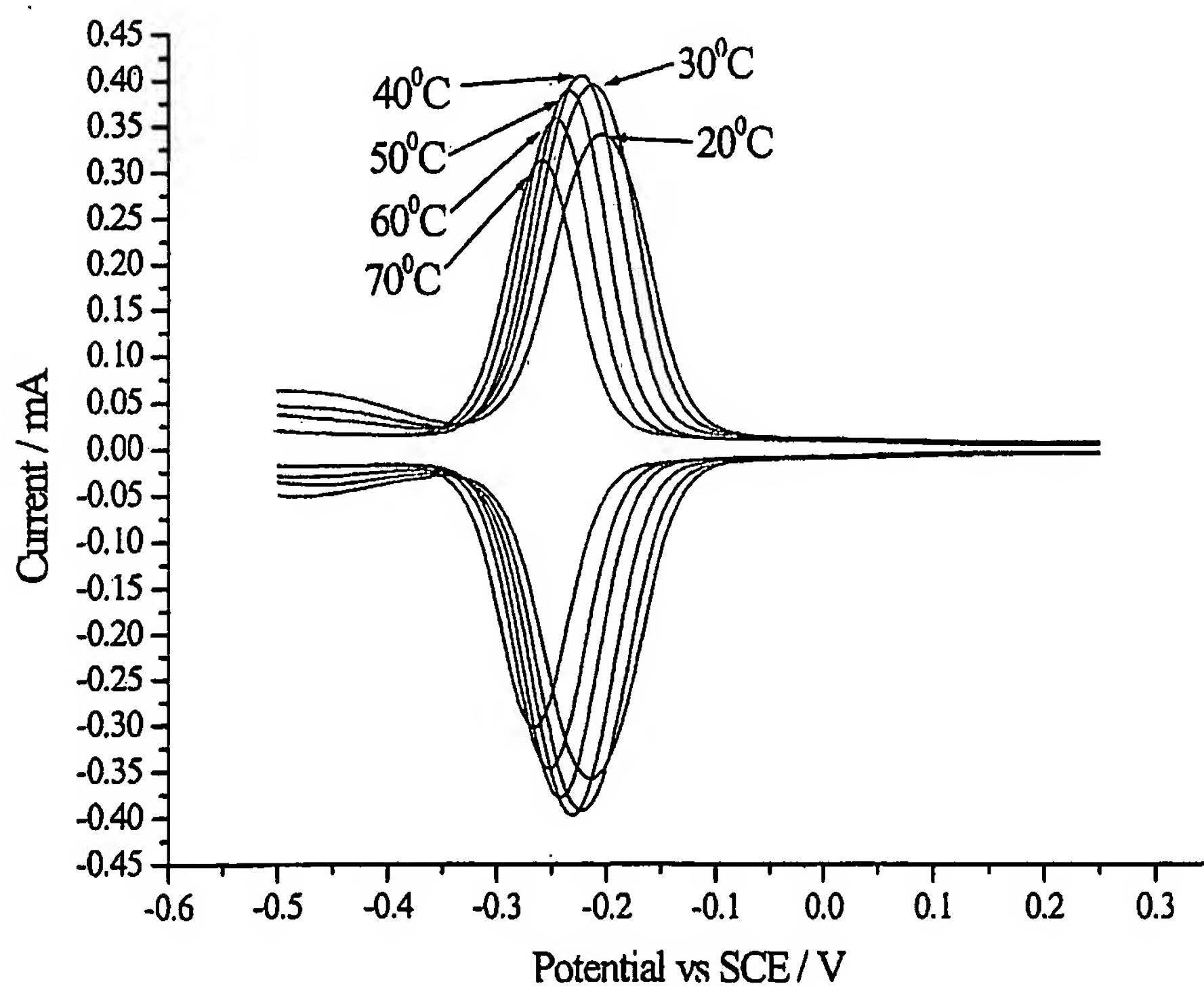


Fig. 39b

WO 2005/085825

PCT/GB2005/000802

35/37

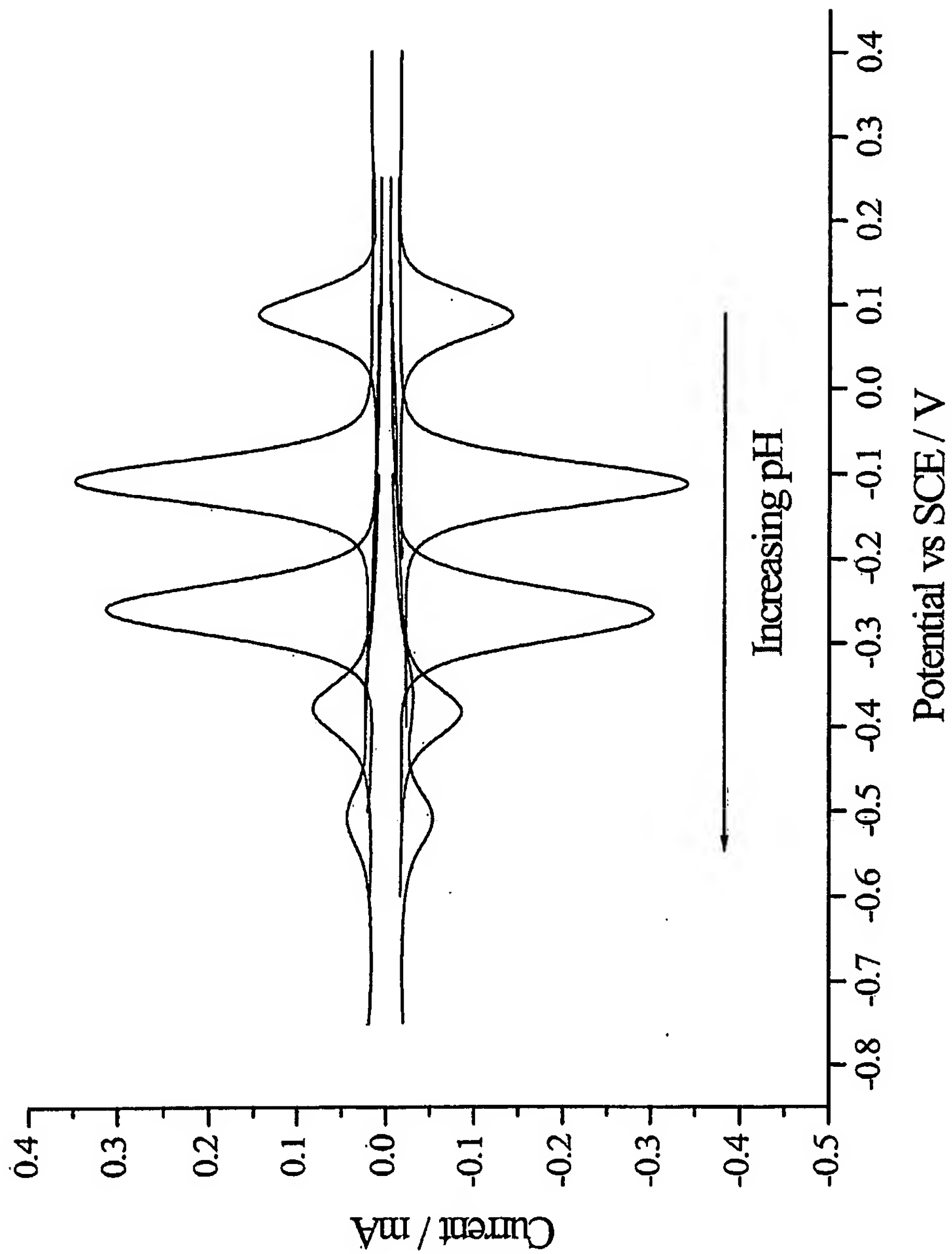


Fig. 40

WO 2005/085825

PCT/GB2005/000802

36/37

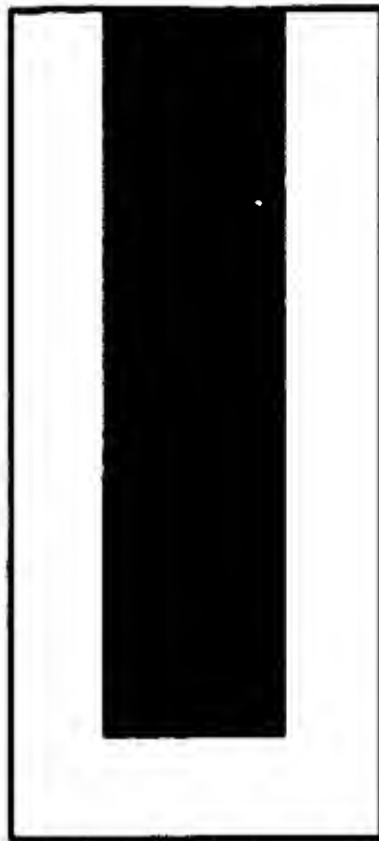


Fig. 41

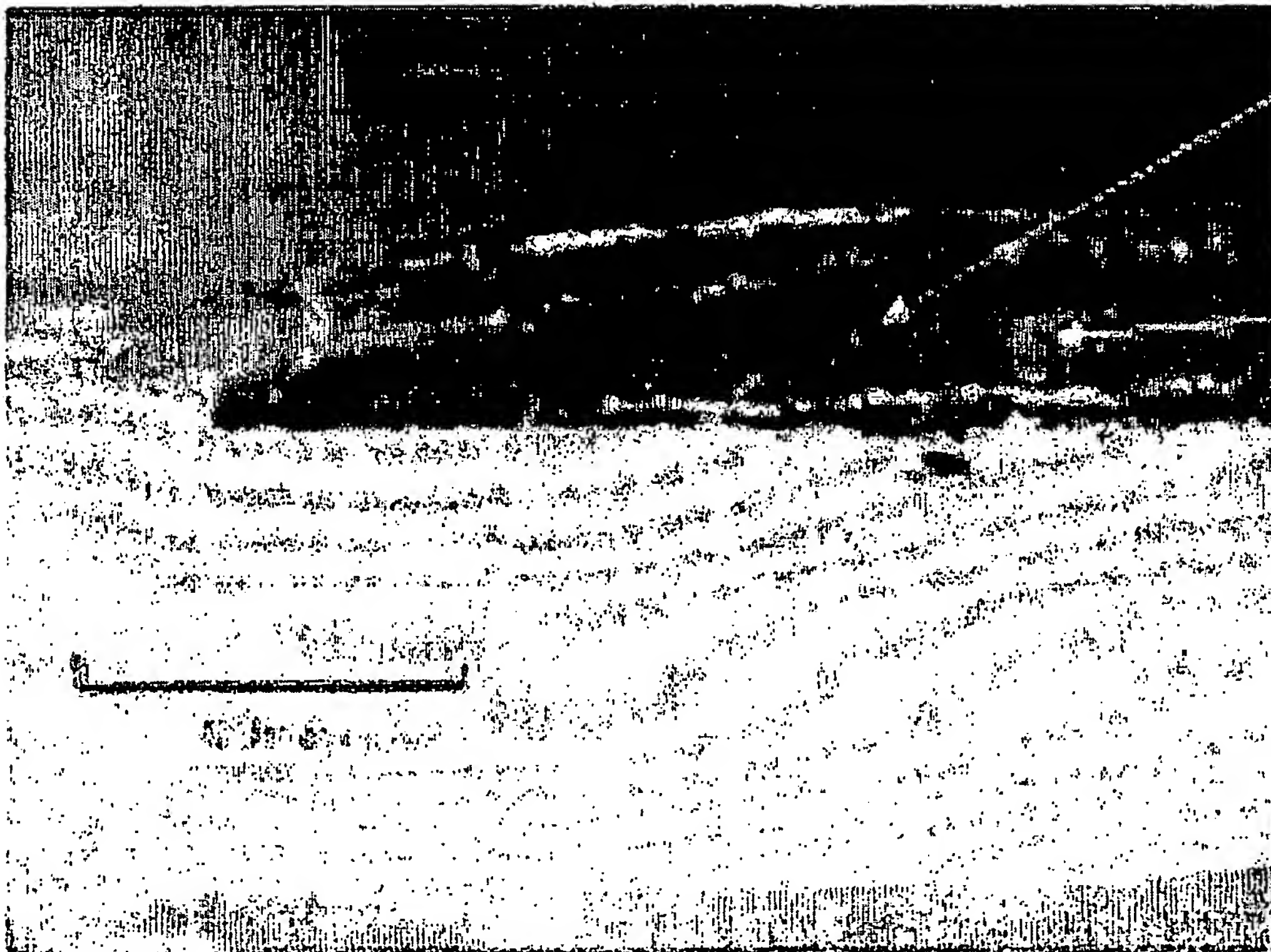


Fig. 42

37/37

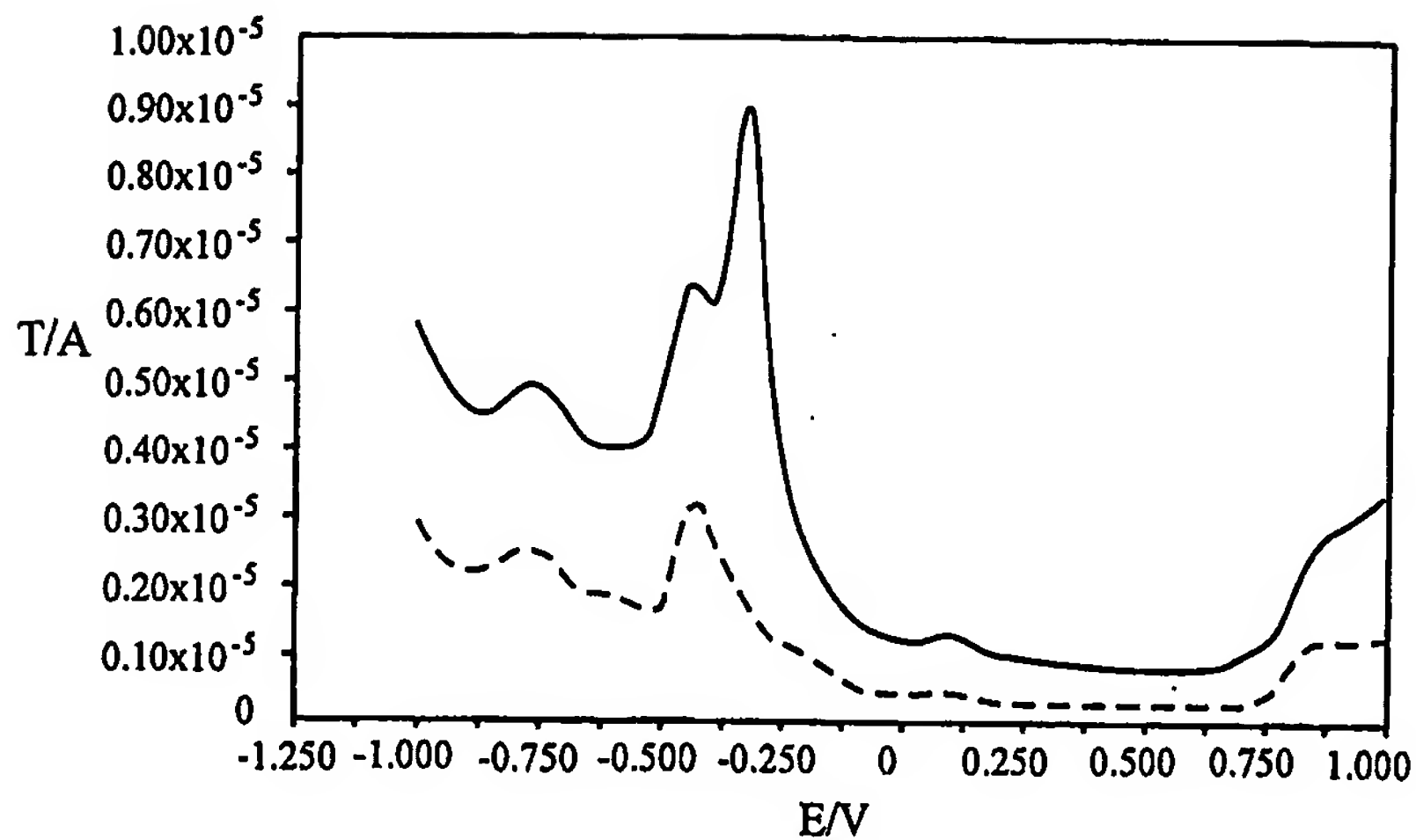


Fig. 43

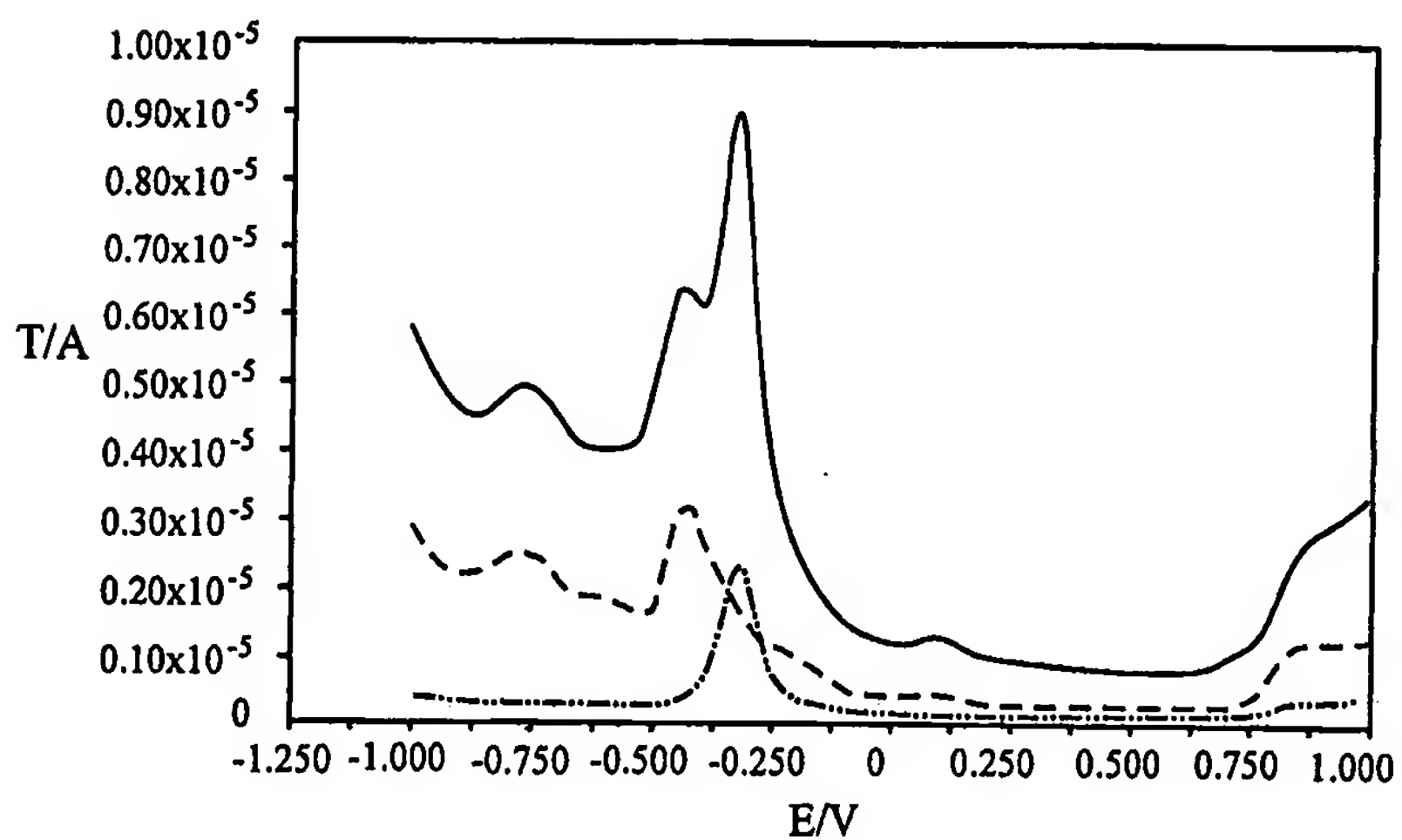


Fig. 44

This Page is Inserted by IFW Indexing and Scanning Operations and is not part of the Official Record.

BEST AVAILABLE IMAGES

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images include but are not limited to the items checked:

- ☐ **BLACK BORDERS**
- ☐ **IMAGE CUT OFF AT TOP, BOTTOM OR SIDES**
- ☐ **FADED TEXT OR DRAWING**
- ☐ **BLURRED OR ILLEGIBLE TEXT OR DRAWING**
- ☐ **SKEWED/SLANTED IMAGES**
- ☒ **COLOR OR BLACK AND WHITE PHOTOGRAPHS**
- ☒ **GRAY SCALE DOCUMENTS**
- ☐ **LINES OR MARKS ON ORIGINAL DOCUMENT**
- ☐ **REFERENCE(S) OR EXHIBIT(S) SUBMITTED ARE POOR QUALITY**
- ☐ **OTHER:** _____

IMAGES ARE BEST AVAILABLE COPY.

As rescanning these documents will not correct the image problems checked, please do not report these problems to the IFW Image Problem Mailbox.